





# Hearing Aid Compatibility (HAC) RF EMISSIONS TEST REPORT

For  
**Verykool USA Inc.**


4350 Executive Dr. #100  
San Diego, USA

**FCC ID: WA6R23**

<b>Report Type:</b> Original Report	<b>Product Type:</b> GSM Mobile Phone
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<b>Report Number:</b>	R1109169-HAC-M
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\* This report may contain data that are not covered by the NVLAP accreditation and are marked with an asterisk "\*" ...

<b>HEARING AID COMPATIBILITY DECLARATION OF COMPLIANCE</b>	
<b>FCC Rule Part(s):</b>	CFR 47 §20.19
<b>HAC Test Procedure(s):</b>	ANSI C63.19-2007
<b>Device Category:</b>	Portable Transmitter Held to Ear
<b>Modulation Type:</b>	GMSK
<b>TX Frequency Range:</b>	824-849 MHz (Cellular Band) 1850-1910 MHz (PCS Band)
<b>HAC Test Configurations:</b>	Cellular, 824.2 836.6 848.8, BT Off, Max Hand free, Backlight Off
	PCS, 1850.2 1880 1909.8, BT Off, Max Hand free, Backlight Off
<b>EUT Type:</b>	Cellular/PCS Phone with Bluetooth
<b>Maximum Conducted Power Tested:</b>	32.97 dBm (Cellular Band) 29.39 dBm (PCS Band)
<b>Battery Type (s) Tested:</b>	3.8 V
<b>Overall HAC Rating</b>	M3/T3
<b>M Category = M3 (ANSI C63.19-2007)</b>	
<p><i>BACL Corp. declares under its sole responsibility that this wireless portable device has been tested for Hearing Aid Compatibility in accordance with the measurement procedures specified in ANSI C63.19-2007.</i></p> <p><i>All measurements reported herein were performed under my supervision and believed to be accurate to the best of my knowledge. I further attest for the completeness of these measurements and vouch for the qualifications any and all personnel performing such measurements.</i></p> <p style="text-align: center;"><b><i>The results and statements contained in this report pertain only to the device(s) evaluated.</i></b></p>	
<p><b><u>Approved by:</u></b></p>          <p style="text-align: center;">VICTOR ZHANG EMC/RF LEAD</p>	<div style="text-align: center;">  </div> <p style="text-align: center;"><b><i>EUT Photo</i></b></p>

**Air Interfaces**

<b>Air-Interface</b>	<b>Band (MHz)</b>	<b>Type</b>	<b>C63.19 tested</b>	<b>Simultaneous Transmissions (Not to be tested)</b>	<b>Reduced power</b>	<b>VOIP</b>
<b>GSM</b>	<b>850</b>	<b>Voice</b>	<b>Yes</b>	<b>Yes: BT</b>	<b>N/A*</b>	<b>YES</b>
	<b>1900</b>				<b>N/A*</b>	<b>YES</b>
<b>BT</b>	<b>2450</b>	<b>Data</b>	<b>N/A*</b>	<b>Yes: GSM</b>	<b>N/A*</b>	<b>N/A*</b>
<b>* HAC Rating was not based on concurrent voice and data modes. Non current mode was found to represent worst case rating for both M and T rating.</b>						

**Remark:**

1, This mobile has two SIM Cards, but SIM Card 1 and SIM Card 2 share the same PCB Board, Schematic, Structure and all components, the only difference between these two cards is their location, after Rough scan, we choose SIM card 1 for test consider it was the worst case.

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**DOCUMENT REVISION HISTORY**

<b>Revision Number</b>	<b>Report Number</b>	<b>Description of Revision</b>	<b>Date of Revision</b>
0	R1109169-HAC-M	Original Report	2011-12-12

# 1 GENERAL INFORMATION

## 1.1 Product Description for the EUT

This Bay Area Compliance Laboratories Corp.(Shenzhen) test report has been prepared on behalf of *Verykool USA Inc.*, and their product GSM Mobile Phone, Model: R23, or the EUT (Equipment Under Test,) as referred to in the rest of this report.

*The test data gathered are from typical production sample, serial number: R1109169-1, provided by BACL (Shenzhen).*

Item	Content
Modulation	GMSK
Frequency Band	Cellular Band: 824-849 MHz PCS Band: 1850-1910 MHz
Dimensions (L x W x H)	110 mm (L) x 50 mm (W) x 20 mm (H)
Weight	78.0 g
Power Source	3.8 V
Operation Mode	Head & Body-worn

## 1.2 Test Facilities and Accreditation

The test site used by Bay Area Compliance Laboratories Corp. (Shenzhen) to collect data is located at 6/F, the 3rd Phase of WanLi Industrial Building, Shi Hua Road, Fu Tian Free Trade Zone, Shenzhen, Guangdong, P.R. of China

Additionally, Bay Area Compliance Laboratories Corp. (Shenzhen) is a National Institute of Standards and Technology (NIST) accredited laboratory, under the National Voluntary Laboratory Accredited Program (Lab Code 200707-0).



The current scope of accreditations can be found at:  
<http://ts.nist.gov/Standards/scopes/2007070.htm>

## 2 STANDARDS AND GUIDELINES

### 2.1 Application Standards

This report describes the methodology and results of experiments performed on wireless data terminal. The objective was to assess the electromagnetic characteristics and operational compatibility and accessibility of hearing aids used with wireless communications devices, including cordless, cellular, and personal communications service (PCS) phones, operating in the range of 800 MHz to 3 GHz.

ANSI C63.19 Clause 7 provides the requirements for acceptable interoperability of hearing aids with wireless devices. When these requirements are met, as defined by the tests described in this standard, a hearing aid operates acceptably with a WD.

Compatibility Tests involved:

The standard calls for wireless communications device to be measured for:

- 1) RF Electric-field emissions
- 2) RF Magnetic-field emissions
- 3) T-coil mode, magnetic-signal strength in the audio band.
- 4) T-coil mode, magnetic-signal frequency response through the audio band.
- 5) T-coil mode, magnetic-signal and noise articulation index

The hearing aid must be measured for:

- 1) RF immunity in microphone mode
- 2) RF immunity in T-coil mode

The categories begin with a minimal level of performance, which is described as “usable.” From this minimum level, steps are provided for both the WD and hearing aid. Improvement in either device moves the performance first to the “regular use” and then to the “excellent performance” categories.

In addition to immunity and emission requirements, hearing aid response performance, as measured by gain, can be adversely affected by WD RF interference. The criterion established Clause 7 sets the requirement for achieving these levels and gain requirements.

The values in Table 1 are built on a set of premises, which are documented in items a) through d).

- a) First, 80 dB(SPL) is assumed as the level of the intended audio input signal.
- b) Secondly, the values given are for an equivalent CW signal. Thus, for hearing aid immunity testing, a CW signal is used to establish a field at the specified RF power level. Then the signal is modulated with 1 kHz, 80% AM modulation for the test. Thus, the peak field strength for the test is higher than the CW level by the increase created by the modulation. In a reciprocal fashion, the peak field emissions from the WD are measured. These are then adjusted by the computed AWF, which reflects the interference potential of the modulation method used.
- c) Finally, the hearing aid gain deviation is a measurement of the gain response change of the hearing aid when exposed to the E- and H-fields created by the dipole.
- d) The category levels represent available volume control adjustment availability. For instance, if the volume control requires 4 dB to 6 dB of adjustment to use the WD, it is considered within the residual reserve gain of the hearing aid but may become a problem during normal use and therefore is considered usable but not acceptable for regular use.

Where a value is contained in two categories, the stricter limit applies.



**Table 1—Hearing aid and telephone near-field parameters**

Category		Telephone RF parameters < 960 MHz			
Near field	AWF	E-field emissions		H-field emissions	
Category M1/T1	0	631.0 to 1122.0	V/m	1.91 to 3.39	A/m
	-5	473.2 to 841.4	V/m	1.43 to 2.54	A/m
Category M2/T2	0	354.8 to 631.0	V/m	1.07 to 1.91	A/m
	-5	266.1 to 473.2	V/m	0.80 to 1.43	A/m
Category M3/T3	0	199.5 to 354.8	V/m	0.60 to 1.07	A/m
	-5	149.6 to 266.1	V/m	0.45 to 0.80	A/m
Category M4/T4	0	< 199.5	V/m	< 0.60	A/m
	-5	< 149.6	V/m	< 0.45	A/m

Category		Telephone RF parameters > 960 MHz			
Near field	AWF	E-field emissions		H-field emissions	
Category M1/T1	0	199.5 to 354.8	V/m	0.60 to 1.07	A/m
	-5	149.6 to 266.1	V/m	0.45 to 0.80	A/m
Category M2/T2	0	112.2 to 199.5	V/m	0.34 to 0.60	A/m
	-5	84.1 to 149.6	V/m	0.25 to 0.45	A/m
Category M3/T3	0	63.1 to 112.2	V/m	0.19 to 0.34	A/m
	-5	47.3 to 84.1	V/m	0.14 to 0.25	A/m
Category M4/T4	0	< 63.1	V/m	< 0.19	A/m
	-5	< 47.3	V/m	< 0.14	A/m

Equipment, which is categorized according to these requirements, shall be coordinated according to Table 2. It should be noted that because the common interference response of hearing aid circuitry is proportional to the square of the RF field, a 5 dB change in the RF yields a 10 dB change in the interference level.

**Table 2—System performance classification table**

System classification	Articulation index (AI)	Category sum of hearing aid category + telephone category
Usable	0.3	Hearing aid category + telephone category = 4
Normal use	0.5	Hearing aid category + telephone category = 5
Excellent performance	0.7	Hearing aid category + telephone category = ≥6

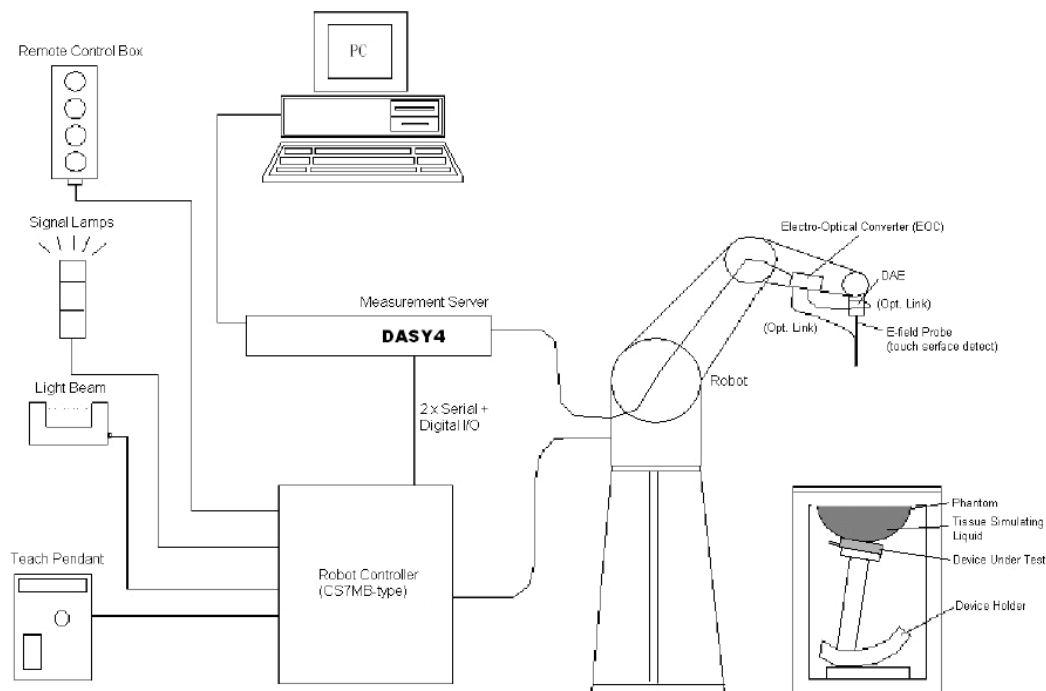
### 3 DESCRIPTION OF TEST SYSTEM

These measurements were performed with the automated near-field scanning system DASY4 from Schmid & Partner Engineering AG (SPEAG) which is the fourth generation of the system shown in the figure hereinafter:



The system is based on a high precision robot (working range greater than 0.9m), which positions the probes with a positional repeatability of better than  $\pm 0.02\text{mm}$ . Special E- and H-field probes have been developed for measurements close to material discontinuity, the sensors of which are directly loaded with a Schottky diode and connected via highly resistive lines to the data acquisition unit.

### 3.1 Measurement System Diagram



The DASY4 system for performing compliance tests consists of the following items:

- A standard high precision 6-axis robot (Stäubli RX family) with controller, teach pendant and software. An arm extension for accommodating the data acquisition electronics (DAE).
- A dosimetric probe, i.e., an isotropic E-field probe optimized and calibrated for usage in tissue simulating liquid. The probe is equipped with an optical surface detector system.
- A Data Acquisition Electronics (DAE) which performs the signal amplification, signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. The unit is battery powered with standard or rechargeable batteries. The signal is optically transmitted to the EOC.
- The Electro-Optical Converter (EOC) performs the conversion between optical and electrical of the signals for the digital communication to the DAE and for the analog signal from the optical surface detection. The EOC is connected to the measurement server.
- The function of the measurement server is to perform the time critical tasks such as signal filtering, control of the robot operation and fast movement interrupts.
- A probe alignment unit which improves the (absolute) accuracy of the probe positioning.
- A computer operating Windows XP.
- DASY4 software.

- Remote control with teach pendant and additional circuitry for robot safety such as warning lamps, etc.
- The SAM twin phantom.
- The device holder for handheld mobile phones.
- Dipole for evaluating the proper functioning of the system.
- Arch Phantom.
- Validation dipole kits allowing it to validate the proper functioning of the system.

### 3.2 System Components

- DASY4 Measurement Server
- Data Acquisition Electronics
- Probes
- Light Beam Unit
- Medium
- SAM Twin Phantom
- Device Holder for SAM Twin Phantom
- System Validation Kits
- Robot

### 3.3 DASY4 Measurement Server

The DASY4 measurement server is based on a PC/104 CPU board with a 166MHz low-power Pentium, 32MB chip disk and 64MB RAM. The necessary circuits for communication with either the DAE4 (or DAE3) electronic box as well as the 16-bit AD-converter system for optical detection and digital I/O interface are contained on the DASY4 I/O-board, which is directly connected to the PC/104 bus of the CPU board.



The measurement server performs all real-time data evaluation for field measurements and surface detection, controls robot movements and handles safety operation. The PC-operating system cannot interfere with these time critical processes. All connections are supervised by a watchdog, and disconnection of any of the cables to the measurement server will automatically disarm the robot and disable all program-controlled robot movements. Furthermore, the measurement server is equipped with two expansion slots which are reserved for future applications. Please note that the expansion slots do not have a standardized pinout and therefore only the expansion cards provided by SPEAG can be inserted. Expansion cards from any other supplier could seriously damage the measurement server.

### 3.4 Data Acquisition Electronics

The data acquisition electronics DAE3 consists of a highly sensitive electrometer grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. Transmission to the measurement server is accomplished through an optical downlink for data and status information as well as an optical uplink for commands and the clock.



### 3.5 Light Beam Unit

The light beam switch allows automatic “tooling” of the probe. During the process, the actual position of the probe tip with respect to the robot arm is measured, as well as the probe length and the horizontal probe offset. The software then corrects all movements, so that the robot coordinates are valid for the probe tip. The repeatability of this process is better than 0.1 mm. If a position has been taught with an aligned probe, the same position will be reached with another aligned probe within 0.1 mm, even if the other probe has different dimensions. During probe rotations, the probe tip will keep its actual position.

### 3.6 Robot

The DASY4 system uses the high precision industrial robots RX60L, RX90 and RX90L, as well as the RX60BL and RX90BL types out of the newer series from Stäubli SA (France). The RX robot series offers many features that are important for our application:

- High precision (repeatability 0.02mm)
- High reliability (industrial design)
- Low maintenance costs (virtually maintenance-free due to direct drive gears; no belt drives)
- Jerk-free straight movements (brushless synchrony motors; no stepper motors)
- Low ELF interference (the closed metallic construction shields against motor control fields)

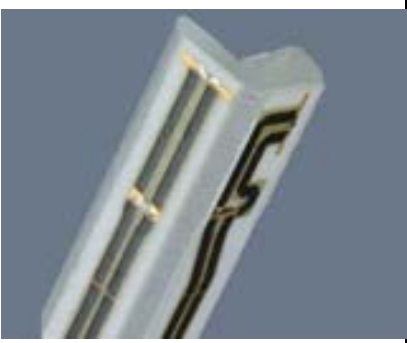
For the newly delivered DASY4 systems as well as for the older DASY3 systems delivered since 1999, the CS7MB robot controller version from Stäubli is used. Previously delivered systems have either a CS7 or CS7M controller; the differences to the CS7MB are mainly in the hardware, but some procedures in the robot software from Stäubli are also not completely the same. The following descriptions about robot hard- and software correspond to CS7MB controller with software version 13.1 (edit S5). The actual commands, procedures and configurations, also including details in hardware, might differ if an older robot controller is in use. In this case please also refer to the Stäubli manuals for further information.




### 3.7 E-Field and H-Field Probes

The HAC measurement is conducted with the dosimetric probe ER3DV6 and H3DV6 (manufactured by SPEAG). The probe is specially designed and calibrated. This probe has a built in optical surface detection system from collision with DUT.

#### ER3DV6 E-Field Probe Description

<b>Construction</b>	One dipole parallel, two dipoles normal to probe axis Built-in shielding against static charges PEEK enclosure material	 <p style="text-align: center;"><b>E-Filed Free-space Probe (ER3DV6)</b></p>
<b>Calibration</b>	In air from 100 MHz to 3.0 GHz (absolute accuracy $\pm 6.0\%$ , $k=2$ )	
<b>Frequency</b>	40 MHz to > 6 GHz (can be extended to < 20 MHz) Linearity: $\pm 0.2$ dB (100 MHz to 3 GHz)	
<b>Directivity</b>	$\pm 0.2$ dB in air (rotation around probe axis) $\pm 0.4$ dB in air (rotation normal to probe axis)	
<b>Dynamic Range</b>	2 V/m to > 1000 V/m; Linearity: $\pm 0.2$ dB	
<b>Dimensions</b>	Overall length: 330 mm (Tip: 16 mm) Tip diameter: 8 mm (Body: 12 mm) Distance from probe tip to dipole centers: 2.5 mm	
<b>Application</b>	General near-field measurements up to 6 GHz Field component measurements Fast automatic scanning in phantoms	

#### H3DV6 H-Field Probe Description

<b>Construction</b>	Three concentric loop sensors with 3.8 mm loop diameters Resistively loaded detector diodes for linear response Built-in shielding against static charges PEEK enclosure material (resistant to organic solvents, e.g., glycoether)	 <p style="text-align: center;"><b>H-Filed Free-space Probe (H3DV6)</b></p>
<b>Frequency</b>	200 MHz to 3 GHz (absolute accuracy $\pm 6.0\%$ , $k=2$ ); Output linearized	
<b>Directivity</b>	$\pm 0.2$ dB (spherical isotropy error)	
<b>Dynamic Range</b>	10 mA/m to 2 A/m at 1 GHz	
<b>E-Field Interference</b>	< 10% at 3 GHz (for plane wave)	
<b>Dimensions</b>	Overall length: 330 mm (Tip: 40 mm) Tip diameter: 6 mm (Body: 12 mm) Distance from probe tip to dipole centers: 3 mm	
<b>Application</b>	General magnetic near-field measurements up to 3 GHz (in air or liquids) Field component measurements Surface current measurements Low interaction with the measured field	

### 3.8 Probes Tip Description

HAC field measurements take place in the close near field gradients. Increasing the measuring distance from the source will generally decrease the measured field values (in case of the validation dipole approx. 10% per mm)

Magnetic field sensors are measuring the integral of H-field across area surrounded by the loop. They are calibrated in a precise, homogeneous field. When measuring a gradient field, the result will be very close to the field in the center of the loop which is equivalent to the value of a homogeneous field equivalent to the center value. But it will be different from the field at the field at the board of the loop.

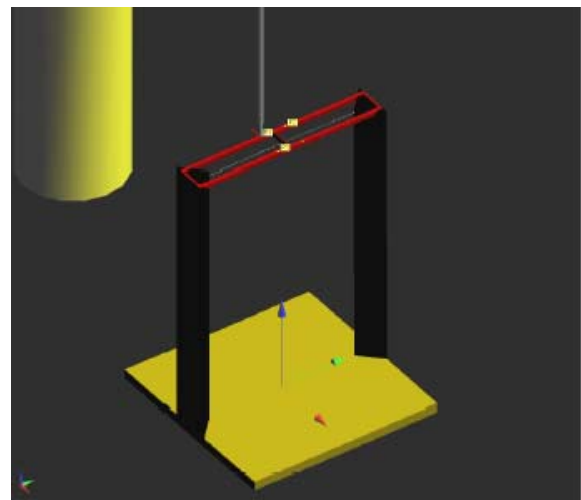
Consequently, two sensors with different loop diameters – both calibrated ideally- would give different results when measuring from the edge of probe of the probe sensor elements. The behavior for electronically small E-field sensors is equivalent.

The magnetic field loops of the H3D probes are concentric, with the center 3 mm from the tip for H3DV6.

The electric field probes have a more irregular internal geometry because it is physically not possible to have the 3 orthogonal sensors situated with the same center. The different sensor center is accounted for in HAC uncertainty budget (“sensor displacement”). Their geometric center is at 2.5 mm from the tip, and the element ends are 1.1 mm closer to the tip.

### 3.9 Device Holder and Phantom

The test Arch phantom should be positioned horizontally on a stable surface. Reference marking on the phantom allows the complete setup of all predefined phantom positions and measurement grids by manually teaching three points in the robot.



The DASY device holder has been made out of low-loss POM material having the following dielectric parameters: relative permittivity  $\epsilon_r=3$  and loss tangent  $\tan \delta=0.02$ . The amount of dielectric material has been reduced in the closest vicinity of the device, since measurements have suggested that the influence of the clamp on the test results could thus be lowered.

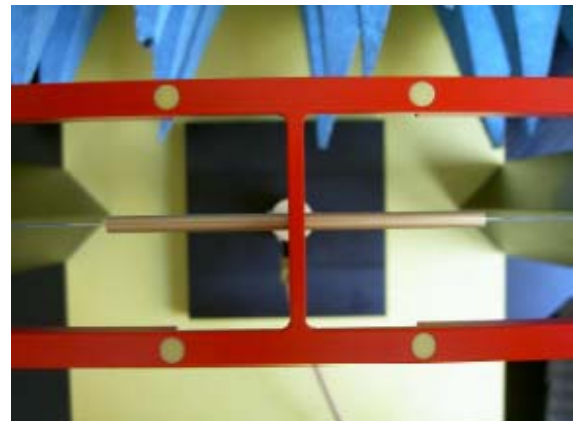


### 3.10 Installation of the Test Arch Phantom

The Test Arch phantom should be positioned horizontally on a stable surface. If the cover of the Twin SAM phantom is used, side shifting after the teaching shall be avoided. In order to allow a vertical position of the probe (for both DASY4 Professional and Compact versions) the section Park position should be not higher than 15mm above the top of the upper Arch frame. For improved user friendliness a predefined configuration file of the Test Arch phantom is provided by SPEAG.

### 3.11 Mounting of a Calibration Dipole

A set of three calibration dipoles (CD835, CD1880 and CD2450) is included as a part of the HAC extension. These are used for the validation of the test setup after its installation and prior to the DUT measurements. The calibration dipole is placed in the position normally occupied by the DUT. All three calibration dipoles have the same high which allows an exact fitting below the center point of the Test Arch.



Insert the base of the calibration dipole fully into the dipole holder and fix it against rotation by tightening the white screw. Connect the RF cable to the dipole and secure it before placing it below the Test Arch phantom in order to avoid mechanical stress to it. Hold the dipole on its plate at the base and press it down against the internal spring to reduce the height.

While holding the dipole down, slide the dipole on its holder centered below the arch, with the arms aligned to the dielectric wire (see graphics above). Release the dipole slowly and guide the gap between the arms into the matching center spacer below the dielectric wire.

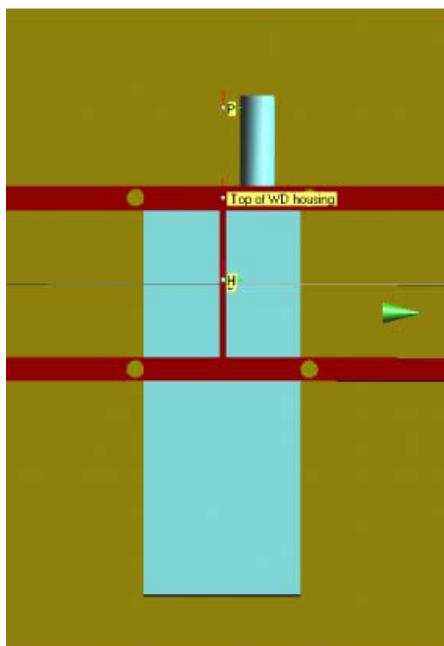
To remove the dipole from the setup press it in the downwards direction before sliding it carefully out from below the arch.



### 3.12 Mounting the DUT

A DUT is mounted in the device holder equivalent as for classic dosimetric measurements. The acoustic output of the DUT shall coincide with the center point of the area formed by the dielectric wire and the middle bar of the arch's top frame (see picture below).

The DUT shall be moved vertically upwards until it touches the frame. The fine adjustment is possible by sliding the complete DUT holder on the yellow base plate of the Test Arch phantom.



### 3.13 System Validation Kits

Each DASY system is equipped with one or more system validation kits. These units, together with the predefined measurement procedures within the DASY software, enable the user to conduct the system performance check and system validation. For that purpose a well defined SAR distribution in the flat section of the SAM twin phantom is produced.

System validation kit includes a dipole, tripod holder to fix it underneath the flat phantom and a corresponding distance holder. Dipoles are available for the variety of frequencies between 300MHz and 6 GHz (dipoles for other frequencies or media and other calibration conditions are available upon request).

The dipoles are highly symmetric and matched at the center frequency for the specified liquid and distance to the flat phantom (or flat section of the SAM-twin phantom). The accurate distance between the liquid surface and the dipole center is achieved with a distance holder that snaps on the dipole.

### 3.14 RF Field Probe Modulation Factor

## 4 TESTING EQUIPMENT LIST AND DETAILS

Type / Model	Calibration Date	Serial Number
DASY4 Professional Dosimetric System	N/A	N/A
Robot RX60L	N/A	CS7MBSP / 467
Robot Controller	N/A	F01/5J72A1/A/01
Dell Computer Dimension 3000	N/A	N/A
SPEAG EDC3	N/A	N/A
SPEAG DAE3	2010-12-07	456
Probe, ER3DV6*	2009-09-22	2338
Probe, H3DV6*	2009-09-22	6158
SPEAG Arch Phantom	N/A	1010
SPEAG Light Alignment Sensor	N/A	278
DASY4 Measurement Server	N/A	1176
Antenna, Dipole, CD835V3*	2009-09-17	1012
Antenna, Dipole, CD1880V3*	2009-09-17	1009
Agilent, Spectrum Analyzer E4440A	2011-08-09	US45303156
Microwave Amp. 8349A	N/A	2644A02662
Power Meter Agilent E4419B	2010-09-01	MY4121511
Power Sensor Agilent E9301A	2011-02-19	US39211706
Analyzer Communication, CMU200	2011-06-29	103492
Dielectric Probe Kit HP85070A	N/A	US99360201
Rohde & Schwarz, Signal Generator, SMIQ03*	2010-03-31	849192/0085
Amplifier, ST181-20	N/A	E012-0101
Antenna, Horn SAS-200/571	2010-09-23	261

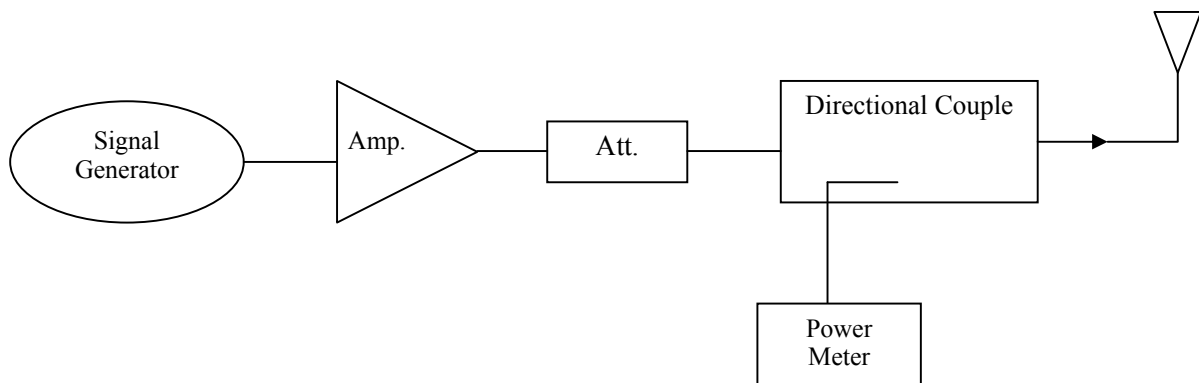
\* Note: "Probe, ER3DV6", "Probe, H3DV6", "Antenna, Dipole, CD835V3", and "Antenna, Dipole, CD1880V3" extended calibration cycle to three years. "Rohde & Schwarz, Signal Generator, SMIQ03" is 2 year calibration cycle.

## 5 HAC MEASUREMENT SYSTEM VERIFICATION

### 5.1 Purpose of System Performance Check

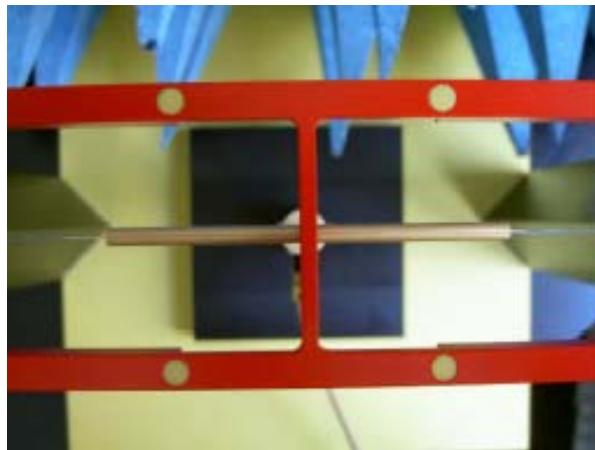
The system performance check verifies that the system operates within its specifications. System and operator errors can be detected and corrected. It is recommended that the system performance check be performed prior to any usage of the system. The system performance check use normal HAC measurements in a simplified setup with a well characterized source. This setup was selected to give a high sensitivity to all parameters that might fail or vary time. The system check does not intend to replace the calibration of the components, but indicates situations where the system uncertainty is exceeded due to drift or failure.

### 5.2 System Performance Check Setup



In the simplified setup for system evaluation, the EUT is replaced by a calibrated dipole and the power source is replaced by a continuous wave which comes from a signal generator at frequency 835 MHz and 1880 MHz. The calibrated dipole must be placed beneath the flat phantom section of ARC with the correct distance holder.

The output power on dipole port must be calibrated to 20 dBm (100 mw) before dipole is connected.



### 5.3 System Validation Results

2011-09-11

**Table A: E-Field System Validation**

Frequency (MHz)	Input Power (dBm)	E-Field Result (V/m)	Target E-Field (V/m)	Deviation (%)
835	20.0	160.6	169.7	-5.36
1880	20.0	149.8	140.0	7.00

**Table B: H-Field System Validation**

Frequency (MHz)	Input Power (dBm)	H-Field Result (A/m)	Target H-Field (A/m)	Deviation (%)
835	20.0	0.461	0.455	1.32
1880	20.0	0.470	0.467	0.64

Note: Deviation = ((E or H-Field Result)-(Target Field))/(Target Field) \* 100 %

Category	AWF (dB)	Limits for E-Field Emissions (V/m) < 960MHz	Limits for H-Field Emissions (A/m) <960MHz
M1	0	631 - 1122	1.91 - 3.39
	-5	473.2 - 841.4	1.43 - 2.54
M2	0	354.8 - 631	1.07 - 1.91
	-5	266.1 - 473.2	0.8 - 1.43
M3	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M4	0	<199.5	<0.6
	-5	<149.6	<0.45

Category	AWF (dB)	Limits for E-Field Emissions (V/m) > 960MHz	Limits for H-Field Emissions (A/m) >960MHz
M1	0	199.5 to 354.8	0.60 to 1.07
	-5	149.6 to 266.1	0.45 to 0.80
M2	0	112.2 to 199.5	0.34 to 0.60
	-5	84.1 to 149.6	0.25 to 0.45
M3	0	63.1 to 112.2	0.19 to 0.34
	-5	47.3 to 84.1	0.14 to 0.25
M4	0	< 63.1	< 0.19
	-5	< 47.3	< 0.14

**Test Laboratory: Bay Area Compliance Lab Corp.(Shenzhen)**

**HAC\_E\_Dipole\_835 System Validation**

**DUT: HAC-Dipole 835 MHz; Type: D835V3; Serial: 1012**

Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1  
 Medium parameters used:  $\sigma = 0$  mho/m,  $\epsilon_r = 1$ ;  $\rho = 1000$  kg/m<sup>3</sup>  
 Phantom section: RF Section

DASY4 Configuration:

- Probe: ER3DV6 - SN2338; ConvF(1, 1, 1); Calibrated: 9/22/2009
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn456; Calibrated: 12/7/2010
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY4, V4.6 Build 23; Post processing SW: SEMCAD, V1.8 Build 184

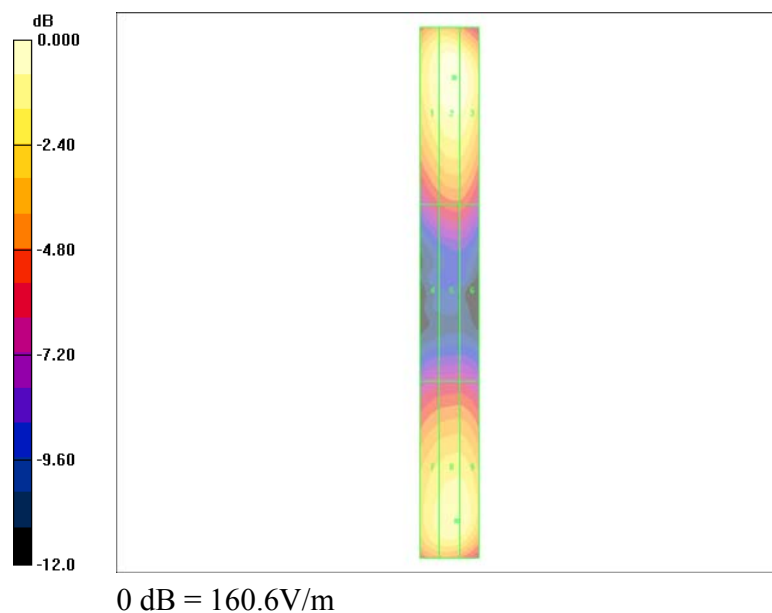
**E Scan 10mm above CD 835 MHz/Hearing Aid Compatibility Test (41x361x1):**

Measurement grid: dx=5mm, dy=5mm  
 Maximum value of peak Total field = 160.6 V/m

**Hearing Aid Near-Field Category: M4 (AWF 0 dB)**

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
<b>150.2 M4</b>	<b>160.6 M4</b>	<b>158.8 M4</b>
Grid 4	Grid 5	Grid 6
<b>83.6 M4</b>	<b>90.0 M4</b>	<b>89.5 M4</b>
Grid 7	Grid 8	Grid 9
<b>138.9 M4</b>	<b>146.9 M4</b>	<b>146.5 M4</b>



**Test Laboratory: Bay Area Compliance Lab Corp.(Shenzhen)**

**HAC\_E\_Dipole\_1880 System Validation**

**DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: 1009**

Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1  
 Medium parameters used:  $\sigma = 0$  mho/m,  $\epsilon_r = 1$ ;  $\rho = 1000$  kg/m<sup>3</sup>  
 Phantom section: RF Section

DASY4 Configuration:

- Probe: ER3DV6 - SN2338; ConvF(1, 1, 1); Calibrated: 9/22/2009
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn456; Calibrated: 12/7/2010
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY4, V4.6 Build 23; Post processing SW: SEMCAD, V1.8 Build 184

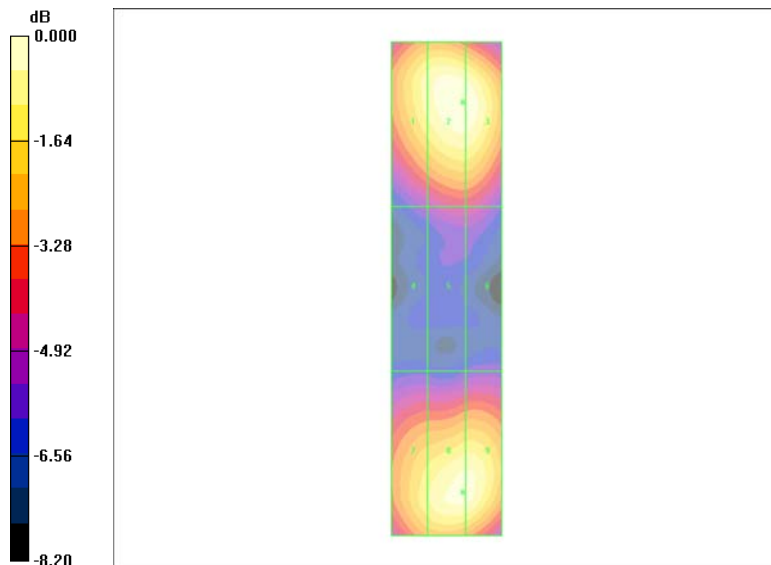
**E Scan 10mm above CD 1880 MHz/Hearing Aid Compatibility Test (41x181x1):**

Measurement grid: dx=5mm, dy=5mm  
 Maximum value of peak Total field = 149.8 V/m

**Hearing Aid Near-Field Category: M2 (AWF 0 dB)**

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
<b>136.6 M2</b>	<b>149.8 M2</b>	<b>149.5 M2</b>
Grid 4	Grid 5	Grid 6
<b>82.2 M3</b>	<b>91.4 M3</b>	<b>91.3 M3</b>
Grid 7	Grid 8	Grid 9
<b>131.2 M2</b>	<b>145.3 M2</b>	<b>145.0 M2</b>



0 dB = 149.8V/m

**Test Laboratory: Bay Area Compliance Lab Corp.(Shenzhen)**

**HAC\_H\_Dipole\_835 System Validation**

**DUT: HAC-Dipole 835 MHz; Type: D835V3; Serial: 1012**

Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1  
 Medium parameters used:  $\sigma = 0$  mho/m,  $\epsilon_r = 1$ ;  $\rho = 1$  kg/m<sup>3</sup>  
 Phantom section: RF Section

DASY4 Configuration:

- Probe: H3DV6 - SN6158; ; Calibrated: 9/22/2009
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn456; Calibrated: 12/7/2010
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY4, V4.6 Build 23; Post processing SW: SEMCAD, V1.8 Build 184

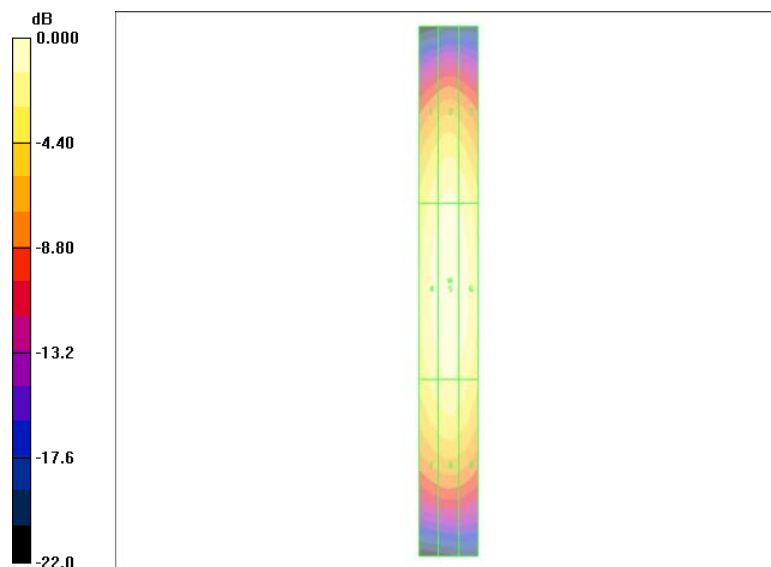
**H Scan 10mm above CD 835 MHz/Hearing Aid Compatibility Test (41x361x1):**

Measurement grid: dx=5mm, dy=5mm  
 Maximum value of peak Total field = 0.461 A/m

**Hearing Aid Near-Field Category: M4 (AWF 0 dB)**

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
<b>0.379 M4</b>	<b>0.408 M4</b>	<b>0.387 M4</b>
Grid 4	Grid 5	Grid 6
<b>0.428 M4</b>	<b>0.461 M4</b>	<b>0.438 M4</b>
Grid 7	Grid 8	Grid 9
<b>0.366 M4</b>	<b>0.389 M4</b>	<b>0.371 M4</b>



0 dB = 0.461A/m

**Test Laboratory: Bay Area Compliance Lab Corp.(Shenzhen)**

**HAC\_H\_Dipole\_1880 System Validation**

**DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: 1009**

Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1  
 Medium parameters used:  $\sigma = 0$  mho/m,  $\epsilon_r = 1$ ;  $\rho = 1$  kg/m<sup>3</sup>  
 Phantom section: RF Section

DASY4 Configuration:

- Probe: H3DV6 - SN6158; ; Calibrated: 9/22/2009
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn456; Calibrated: 12/7/2010
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY4, V4.6 Build 23; Post processing SW: SEMCAD, V1.8 Build 184

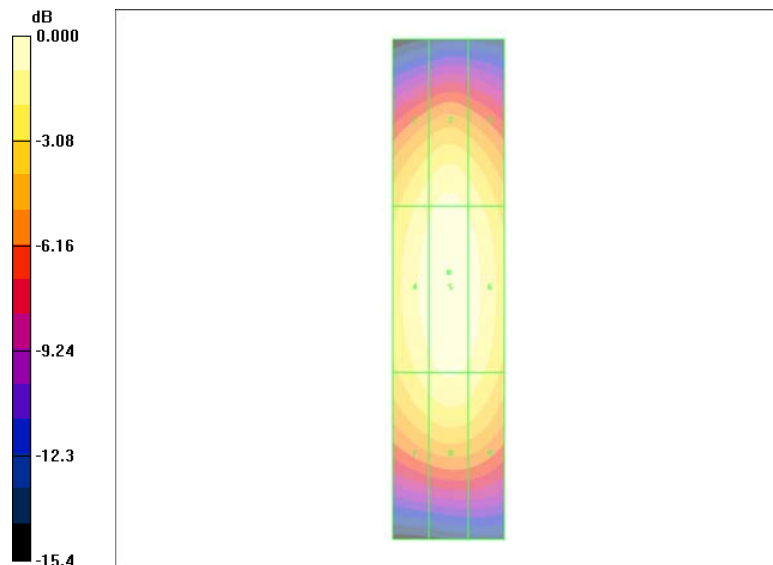
**H Scan 10mm above CD 1880 MHz/Hearing Aid Compatibility Test (41x181x1):**

Measurement grid: dx=5mm, dy=5mm  
 Maximum value of peak Total field = 0.470 A/m

**Hearing Aid Near-Field Category: M2 (AWF 0 dB)**

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
<b>0.405 M2</b>	<b>0.434 M2</b>	<b>0.410 M2</b>
Grid 4	Grid 5	Grid 6
<b>0.441 M2</b>	<b>0.470 M2</b>	<b>0.449 M2</b>
Grid 7	Grid 8	Grid 9
<b>0.398 M2</b>	<b>0.424 M2</b>	<b>0.407 M2</b>



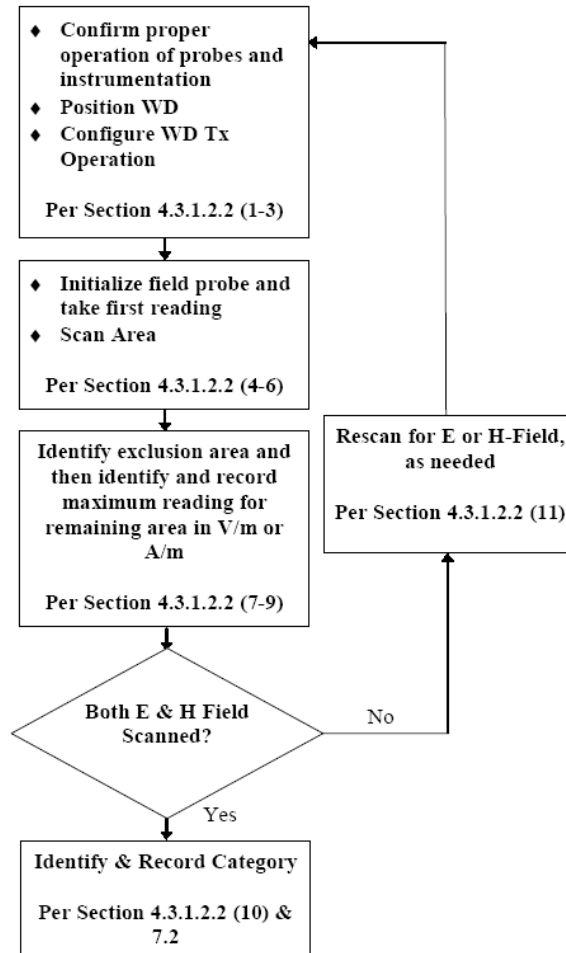
0 dB = 0.470A/m



## 6 HAC RF EMISSIONS TEST PROCEDURE

### 6.1 Test Instructions

#### Test Instructions



### 6.2 Test Setup

Figure 1 through Figure 3 illustrates the references and reference plane that shall be used in the WD emissions measurement.

- 1) The grid is 5.0 cm by 5.0 cm area that is divided into nine evenly sized blocks or sub-grids.
- 2) The grid is centered on the audio frequency output transducer of the WD (speaker or T-Coil).
- 3) The grid is in a reference plane, which is defined as the planar area that contains the highest point in the area of the phone that normally rests against the user’s ear. It is parallel to the centerline of the receiver area of the phone and is defined by the points of the receiver-end of the WD handset, which, in normal handset use, rest against the ear.
- 4) The measurement plane is parallel to, and 10.0 mm in front of, the reference plane.



Figure 1. WD reference and plan for RF emission measurement

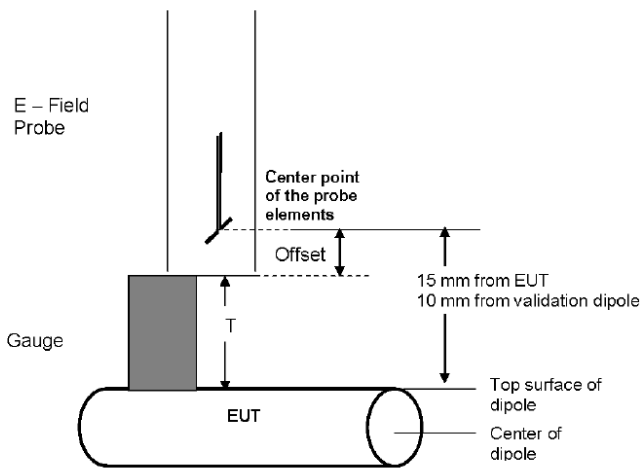


Figure 2. Gauge Block with E-field Probe

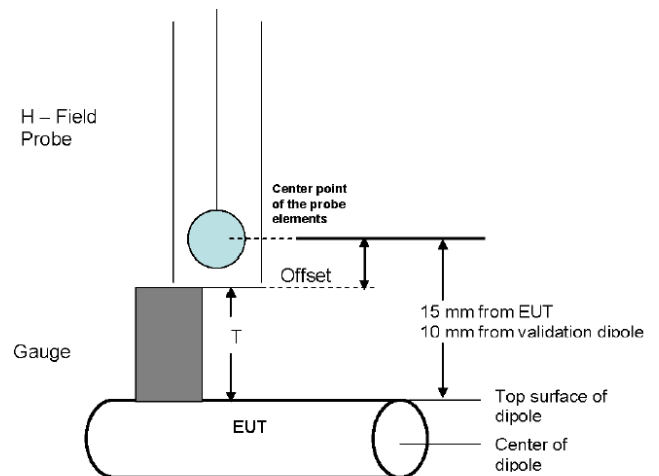


Figure 3. Gauge Block with H-field Probe

### 6.3 Near-Field Test Procedure

The electric field probe, and, separately, the magnetic field probe, is to be used to measure the highest field strength in the 5 cm by 5 cm scan surface. The average field strength measured over many pulse cycles may be measured, with the peak then being calculated from the measured average value and the known duty cycle of the WD.

The 5 cm by 5 cm area is divided into nine subgrids (see the diagram in Figure A.2). Three contiguous subgrids on the perimeter may be excluded from the measurement. This allows for RF "hot spots" that can easily be avoided in actual use. The highest reading found in the area defined by the middle subgrid and the remaining

subgrids determines the category rating. The field probe is carefully moved through the measurement area and the maximum reading is located. In order to accurately scan the entire 5 cm by 5 cm area, the center of the probe shall be moved through this area. Accordingly the total area covered by the outside edge of the probe shall be the 5 cm by 5 cm area, increased by half (1/2) the probe diameter on all sides.

The method of displaying the data is not important as long as good measurement techniques are followed and the resultant highest field strength is obtained.

The distance from the WD reference plane to the nearest point on the probe element shall be 1.0 cm. The WD reference plane is a plane parallel with the front "face" of the WD and containing the highest point on its contour. The probe element is that portion of the probe that is designed to receive and sense the field being measured. The physical body of the probe housing shall not be used when setting this 1.0 cm distance as this would place the sensing elements at an indeterminate distance from the reference plane. Although it is theoretically possible to measure at almost any distance and calculate the equivalent field strengths at 1.0 cm, it is not recommended as these calculations are very difficult and prone to errors.

In the case of a field probe that may have less than three orthogonal elements, it is necessary to rotate the probe to obtain the measurement. Two methods may be used. In the preferred method, the probe shall be rotated in three dimensions for maximum alignment and the reading at maximum field alignment used. An alternative method is to rotate the probe about its geometric center so as to obtain measurements in all three mutually orthogonal orientations. The geometric center is the point that is physically located at the center of the electromagnetic sensing element of the probe. This may be determined from physical measurements or from field pattern measurements during calibration. The maximum field shall be the vector sum of all three individual mutually orthogonal measurements. Note that even when using three element probes, the probe may be rotated so as to align one element for maximum field coupling. When this is done the reading of the single, maximally aligned element is used as the field reading at that location. Readings taken in this manner are preferred over those taken with the non-aligned method because of the greater accuracy. However, when the alignment method is used, the probe shall be realigned at every measurement point.

## 7 MEASUREMENT UNCERTAINTY

The uncertainty budget has been determined for the DASY4 measurement system and is given in the following Table:

Wireless Communication Device Near-Field Measurement Uncertainty Estimation (According to ANSI C63.19)							
Error Description	Uncertainty Value	Prob. Dist.	Div.	(c i) E	(c i) H	Std. Unc. (E)	Std. Unc. H
<b>Measurement System</b>							
Probe Calibration	± 5.1 %	N	1	1	1	± 5.1 %	±5.1%
Axial Isotropy	± 4.7%	R	√3	1	1	±2.7%	±2.7%
Sensor Displacement	±16.5%	R	√3	1	0.145	±9.5%	±1.4%
Test Arch	±7.2%	R	√3	1	0	±4.1%	±0.0%
Linearity	±4.7%	R	√3	1	1	±2.7%	±2.7%
Scaling to Peak Envelope Power	±0.0%	R	√3	1	1	±0.0%	±0.0%
System Detection Limit	±1.0%	R	√3	1	1	±0.6%	±0.6%
Readout Electronics	±0.3%	N	1	1	1	±0.3%	±0.3%
Response Time	±0.8%	R	√3	1	1	±0.5%	±0.5%
Integration Time	±2.6%	R	√3	1	1	±1.5%	±1.5%
RF Ambient Conditions	±3.0%	R	√3	1	1	±1.7%	±1.7%
RF Reflections	±12.0%	R	√3	1	1	±6.9%	±6.9%
Probe Positioner	±1.2%	R	√3	1	0.67	±0.7%	±0.5%
Probe Positioning	±4.7%	R	√3	1	0.67	±2.7%	±1.8%
Extrap. and Interpolation	±1.0%	R	√3	1	1	±0.6%	±0.6%
<b>Test Sample Related</b>							
Device Positioning Vertical	±4.7%	R	√3	1	0.67	±2.7%	±1.8%
Device Positioning Lateral	±1.0%	R	√3	1	1	±0.6%	±0.6%
Device Holder and Phantom	±2.4%	R	√3	1	1	±1.4%	±1.4%
Power Drift	±5.0%	R	√3	1	1	±2.9%	±2.9%
<b>Phantom and Setup Related</b>							
Phantom Thickness	± 2.4%	R	√3	1	0.67	±1.4%	±0.9%
Combined Std. Uncertainty						±15.2%	±10.8%
Expanded Std. Uncertainty on Power						±30.4%	±21.6%
Expanded Std. Uncertainty on Field						±15.2%	±10.8%

## 8 HAC MEASUREMENT SUMMARY

### 8.1 HAC Test Data

This page summarizes the results of the performed dosimetric evaluation. The plots with the corresponding E & H Fields distributions, which reveal information about the category of the wireless communication device with respect to the HAC test result, could be found in Appendix A.

### 8.2 Test Environmental Conditions

<b>Ambient Temperature:</b>	20~23 °C
<b>Relative Humidity:</b>	43~48 %
<b>ATM Pressure:</b>	101~103kPa

Testing was performed by Arthur Tie on 2011-09-11 and 2011-09-14 in the SAR Chamber.

2011-09-11

Frequency (MHz)	Test Type	Medium	Phantom	Notes / Accessories	Peak Field (V/m, E-Field) (A/m, H-Field)	HAC Category	Plot #
824.2	E-Field	Air	Arch	none	149.7	M3	1
836.6	E-Field	Air	Arch	none	164.4	M3	2
848.8	E-Field	Air	Arch	none	173.9	M3	3
1850.2	E-Field	Air	Arch	none	81.6	M3	4
1880	E-Field	Air	Arch	none	78.7	M3	5
1909.8	E-Field	Air	Arch	none	78.8	M3	6

2011-09-12

Frequency (MHz)	Test Type	Medium	Phantom	Notes / Accessories	Peak Field (V/m, E-Field) (A/m, H-Field)	HAC Category	Plot #
824.2	H-Field	Air	Arch	none	0.149	M4	7
836.6	H-Field	Air	Arch	none	0.163	M4	8
848.8	H-Field	Air	Arch	none	0.167	M4	9
1850.2	H-Field	Air	Arch	none	0.151	M3	10
1880	H-Field	Air	Arch	none	0.142	M3	11
1909.8	H-Field	Air	Arch	none	0.132	M4	12

## 9 APPENDIX A – HAC MEASUREMENT RESULTS

### 835 E Field Testing Low CH

**DUT: VeryCool USA Inc.; Type: Mobile phone; Serial: R1109169-1**

Communication System: GSM 850; Frequency: 824.2 MHz; Duty Cycle: 1:8.3  
 Medium parameters used:  $\sigma = 0$  mho/m,  $\epsilon_r = 1$ ;  $\rho = 1000$  kg/m<sup>3</sup>  
 Phantom section: RF Section

DASY4 Configuration:

- Probe: ER3DV6 - SN2338; ConvF(1, 1, 1); Calibrated: 9/22/2009
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn456; Calibrated: 12/7/2010
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial:
- Measurement SW: DASY4, V4.7 Build 80; Post processing SW: SEMCAD, V1.8 Build 186

**E Scan 10mm above CD 2/Hearing Aid Compatibility Test (61x61x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 149.7 V/m

Probe Modulation Factor = 2.88

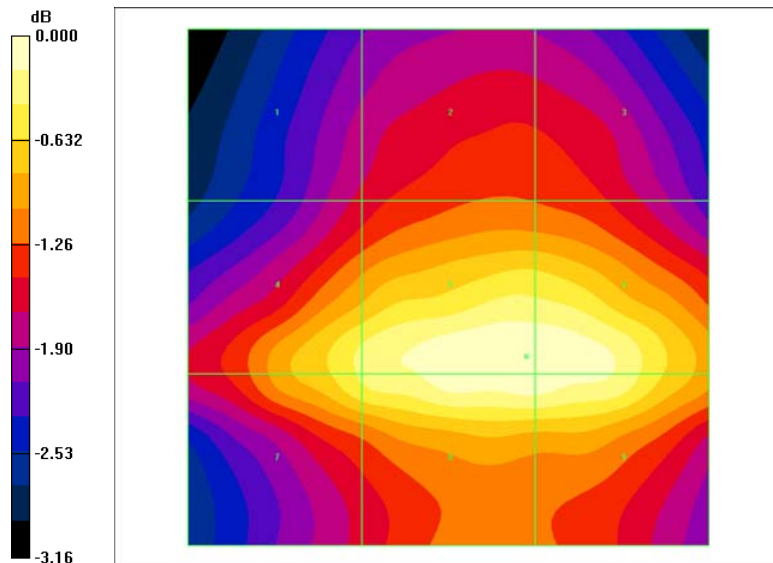
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 47.1 V/m; Power Drift = -0.016 dB

**Hearing Aid Near-Field Category: M3 (AWF -5 dB)**

Peak E-field in V/m

Grid 1 <b>124.5 M4</b>	Grid 2 <b>129.8 M4</b>	Grid 3 <b>129.4 M4</b>
Grid 4 <b>143.7 M4</b>	Grid 5 <b>149.7 M3</b>	Grid 6 <b>149.5 M4</b>
Grid 7 <b>143.4 M4</b>	Grid 8 <b>149.2 M4</b>	Grid 9 <b>149.1 M4</b>



0 dB = 149.7V/m

**Plot # 1**

**835 E Field Testing Mid CH**

**DUT: VeryCool USA Inc.; Type: Mobile phone; Serial: R1109169-1**

Communication System: GSM 850; Frequency: 836.6 MHz; Duty Cycle: 1:8.3  
 Medium parameters used:  $\sigma = 0$  mho/m,  $\epsilon_r = 1$ ;  $\rho = 1000$  kg/m<sup>3</sup>  
 Phantom section: RF Section

DASY4 Configuration:

- Probe: ER3DV6 - SN2338; ConvF(1, 1, 1); Calibrated: 9/22/2009
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn456; Calibrated: 12/7/2010
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial:
- Measurement SW: DASY4, V4.7 Build 80; Post processing SW: SEMCAD, V1.8 Build 186

**E Scan 10mm above CD 2/Hearing Aid Compatibility Test (61x61x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 164.4 V/m

Probe Modulation Factor = 2.88

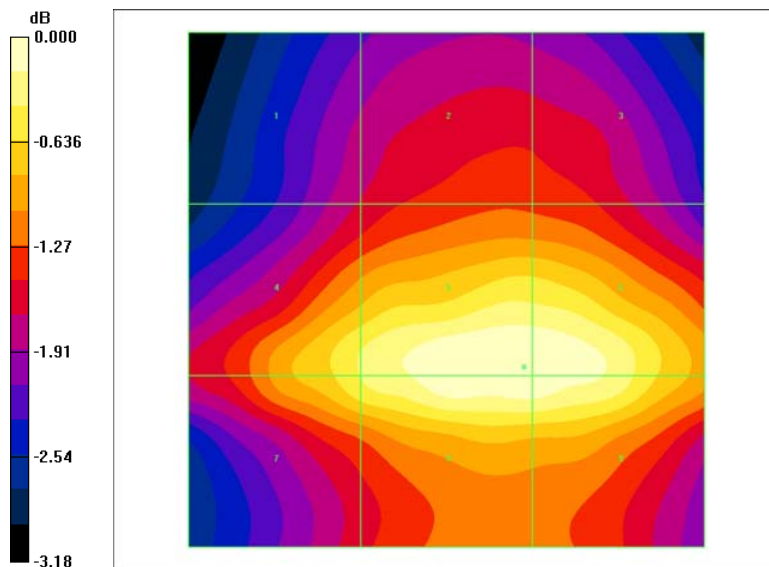
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 51.2 V/m; Power Drift = 0.025 dB

**Hearing Aid Near-Field Category: M3 (AWF -5 dB)**

Peak E-field in V/m

Grid 1 <b>135.8 M4</b>	Grid 2 <b>141.6 M4</b>	Grid 3 <b>141.2 M4</b>
Grid 4 <b>157.1 M3</b>	Grid 5 <b>164.4 M3</b>	Grid 6 <b>164.2 M3</b>
Grid 7 <b>156.8 M3</b>	Grid 8 <b>164.1 M3</b>	Grid 9 <b>163.9 M3</b>



0 dB = 164.4V/m

**Plot #2**

**835 E Field Testing High CH**

**DUT: VeryCool USA Inc.; Type: Mobile phone; Serial: R1109169-1**

Communication System: GSM 850; Frequency: 848.8 MHz; Duty Cycle: 1:8.3

Medium parameters used:  $\sigma = 0$  mho/m,  $\epsilon_r = 1$ ;  $\rho = 1000$  kg/m<sup>3</sup>

Phantom section: RF Section

DASY4 Configuration:

- Probe: ER3DV6 - SN2338; ConvF(1, 1, 1); Calibrated: 9/22/2009
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn456; Calibrated: 12/7/2010
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial:
- Measurement SW: DASY4, V4.7 Build 80; Post processing SW: SEMCAD, V1.8 Build 186

**E Scan 10mm above CD 2/Hearing Aid Compatibility Test (61x61x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 173.9 V/m

Probe Modulation Factor = 2.88

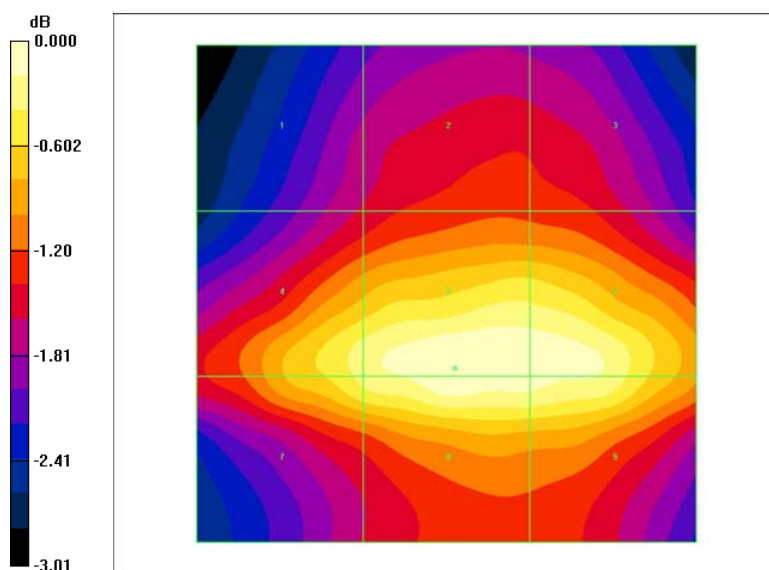
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 55.3 V/m; Power Drift = -0.041 dB

**Hearing Aid Near-Field Category: M3 (AWF -5 dB)**

Peak E-field in V/m

Grid 1 <b>145.3 M4</b>	Grid 2 <b>150.8 M3</b>	Grid 3 <b>150.3 M3</b>
Grid 4 <b>168.2 M3</b>	Grid 5 <b>173.9 M3</b>	Grid 6 <b>172.6 M3</b>
Grid 7 <b>167.5 M3</b>	Grid 8 <b>173.4 M3</b>	Grid 9 <b>171.8 M3</b>



0 dB = 173.9V/m

**Plot #3**



**1900 E Field Testing Low CH**

**DUT: VeryCool USA Inc.; Type: Mobile phone; Serial: R1109169-1**

Communication System: PCS 1900; Frequency: 1850.2 MHz; Duty Cycle: 1:8.3  
 Medium parameters used:  $\sigma = 0$  mho/m,  $\epsilon_r = 1$ ;  $\rho = 1000$  kg/m<sup>3</sup>  
 Phantom section: RF Section

DASY4 Configuration:

- Probe: ER3DV6 - SN2338; ConvF(1, 1, 1); Calibrated: 9/22/2009
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn456; Calibrated: 12/7/2010
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial:
- Measurement SW: DASY4, V4.7 Build 80; Post processing SW: SEMCAD, V1.8 Build 186

**E Scan 10mm above CD 2/Hearing Aid Compatibility Test (61x61x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 81.6 V/m

Probe Modulation Factor = 2.88

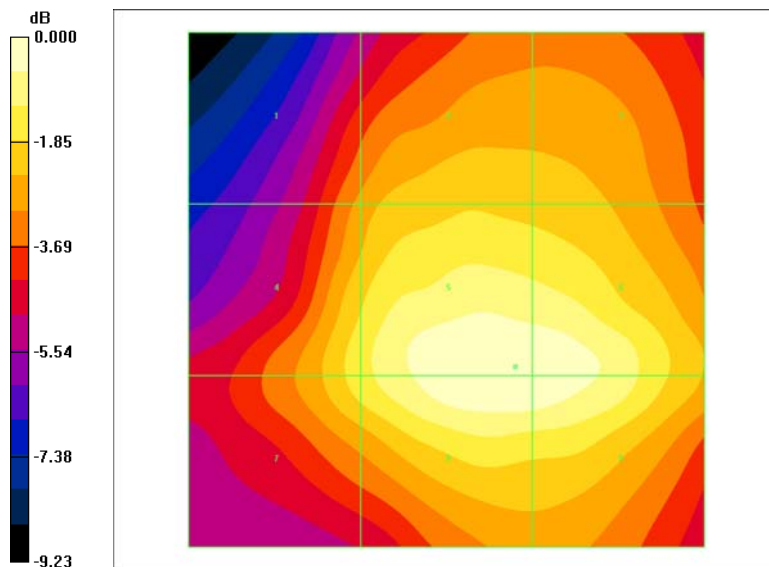
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 32.1 V/m; Power Drift = -0.803 dB

**Hearing Aid Near-Field Category: M3 (AWF -5 dB)**

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
<b>53.0 M3</b>	<b>61.6 M3</b>	<b>60.3 M3</b>
Grid 4	Grid 5	Grid 6
<b>75.8 M3</b>	<b>81.6 M3</b>	<b>81.3 M3</b>
Grid 7	Grid 8	Grid 9
<b>75.6 M3</b>	<b>81.3 M3</b>	<b>80.9 M3</b>



0 dB = 101.6V/m

**Plot #4**

**1900 E Field Testing Mid CH**

**DUT: VeryCool USA Inc.; Type: Mobile phone; Serial: R1109169-1**

Communication System: PCS 1900; Frequency: 1880 MHz; Duty Cycle: 1:8.3  
 Medium parameters used:  $\sigma = 0$  mho/m,  $\epsilon_r = 1$ ;  $\rho = 1000$  kg/m<sup>3</sup>  
 Phantom section: RF Section

DASY4 Configuration:

- Probe: ER3DV6 - SN2338; ConvF(1, 1, 1); Calibrated: 9/22/2009
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn456; Calibrated: 12/7/2010
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial:
- Measurement SW: DASY4, V4.7 Build 80; Post processing SW: SEMCAD, V1.8 Build 186

**E Scan 10mm above CD 2/Hearing Aid Compatibility Test (61x61x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 78.7 V/m

Probe Modulation Factor = 2.88

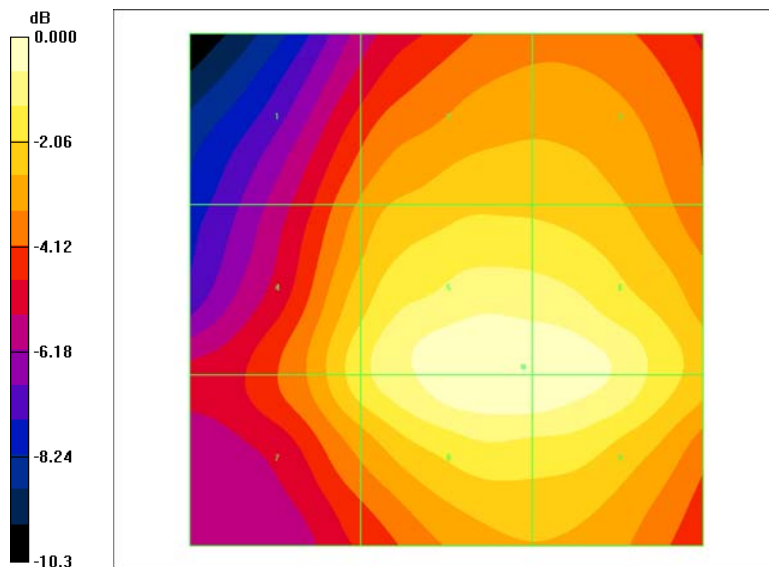
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 27.3 V/m; Power Drift = 0.221 dB

**Hearing Aid Near-Field Category: M3 (AWF -5 dB)**

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
<b>57.6 M3</b>	<b>66.9 M3</b>	<b>66.6 M3</b>
Grid 4	Grid 5	Grid 6
<b>62.1 M3</b>	<b>78.7 M3</b>	<b>78.5 M3</b>
Grid 7	Grid 8	Grid 9
<b>61.9 M3</b>	<b>78.4 M3</b>	<b>78.3 M3</b>



0 dB = 98.7V/m

**Plot #5**

**1900 E Field Testing High CH**

**DUT: VeryCool USA Inc.; Type: Mobile phone; Serial: R1109169-1**

Communication System: PCS 1900; Frequency: 1909.8 MHz; Duty Cycle: 1:8.3  
 Medium parameters used:  $\sigma = 0$  mho/m,  $\epsilon_r = 1$ ;  $\rho = 1000$  kg/m<sup>3</sup>  
 Phantom section: RF Section

DASY4 Configuration:

- Probe: ER3DV6 - SN2338; ConvF(1, 1, 1); Calibrated: 9/22/2009
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn456; Calibrated: 12/7/2010
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial:
- Measurement SW: DASY4, V4.7 Build 80; Post processing SW: SEMCAD, V1.8 Build 186

**E Scan 10mm above CD 2/Hearing Aid Compatibility Test (61x61x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 78.8 V/m

Probe Modulation Factor = 2.88

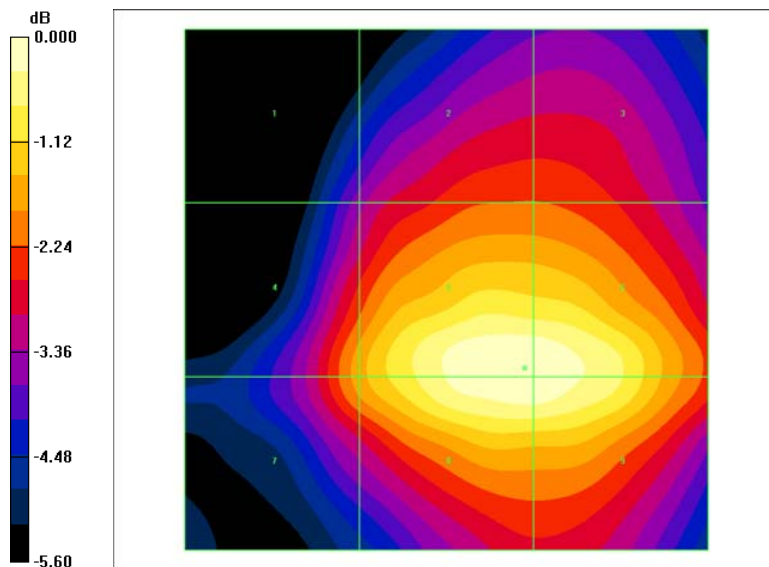
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 27.9 V/m; Power Drift = -0.050 dB

**Hearing Aid Near-Field Category: M3 (AWF -5 dB)**

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
<b>56.1 M3</b>	<b>66.6 M3</b>	<b>66.6 M3</b>
Grid 4	Grid 5	Grid 6
<b>61.8 M3</b>	<b>78.8 M3</b>	<b>78.7 M3</b>
Grid 7	Grid 8	Grid 9
<b>61.7 M3</b>	<b>78.6 M3</b>	<b>78.5 M3</b>



0 dB = 98.8V/m

**Plot #6**

**850 H Field Testing Low CH**

**DUT: VeryCool USA Inc.; Type: Mobile phone; Serial: R1109169-1**

Communication System: GSM 850; Frequency: 824.2 MHz; Duty Cycle: 1:8.3  
 Medium parameters used:  $\sigma = 0.95$  mho/m,  $\epsilon_r = 55.96$ ;  $\rho = 1$  kg/m<sup>3</sup>  
 Phantom section: RF Section

DASY4 Configuration:

- Probe: H3DV6 - SN6158; ; Calibrated: 9/22/2009
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn456; Calibrated: 12/7/2010
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial:
- Measurement SW: DASY4, V4.7 Build 80; Post processing SW: SEMCAD, V1.8 Build 186

**H Scan 10mm above CD 835 MHz/Hearing Aid Compatibility Test (61x61x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.212 A/m

Probe Modulation Factor = 2.88

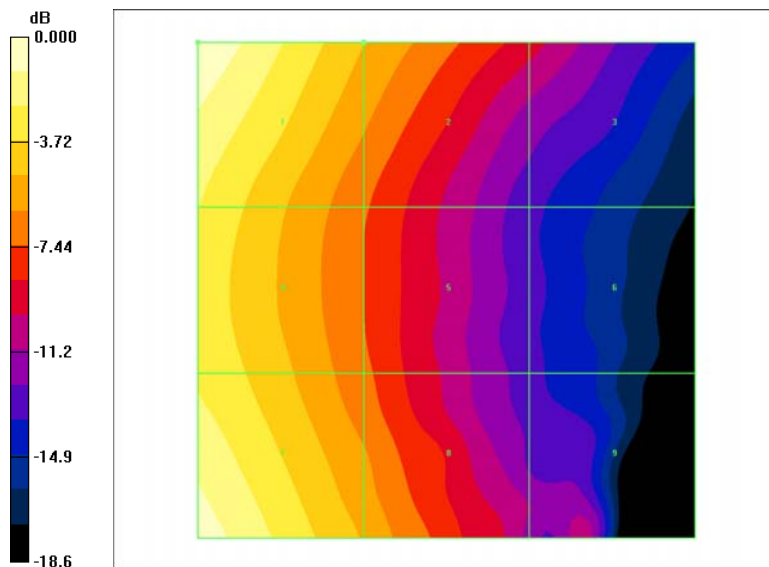
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.043 A/m; Power Drift = -9.83 dB

**Hearing Aid Near-Field Category: M4 (AWF -5 dB)**

Peak H-field in A/m

Grid 1 <b>0.212 M4</b>	Grid 2 <b>0.166 M4</b>	Grid 3 <b>0.134 M4</b>
Grid 4 <b>0.188 M4</b>	Grid 5 <b>0.149 M4</b>	Grid 6 <b>0.112 M4</b>
Grid 7 <b>0.207 M4</b>	Grid 8 <b>0.165 M4</b>	Grid 9 <b>0.127 M4</b>



0 dB = 0.212A/m

**Plot #7**

**850 H Field Testing Mid CH**

**DUT: VeryCool USA Inc.; Type: Mobile phone; Serial: R1109169-1**

Communication System: GSM 850; Frequency: 836.6 MHz; Duty Cycle: 1:8.3  
 Medium parameters used:  $\sigma = 0.96$  mho/m,  $\epsilon_r = 55.86$ ;  $\rho = 1$  kg/m<sup>3</sup>  
 Phantom section: RF Section

DASY4 Configuration:

- Probe: H3DV6 - SN6158; ; Calibrated: 9/22/2009
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn456; Calibrated: 12/7/2010
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial:
- Measurement SW: DASY4, V4.7 Build 80; Post processing SW: SEMCAD, V1.8 Build 186

**H Scan 10mm above CD 835 MHz/Hearing Aid Compatibility Test (61x61x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.235 A/m

Probe Modulation Factor = 2.88

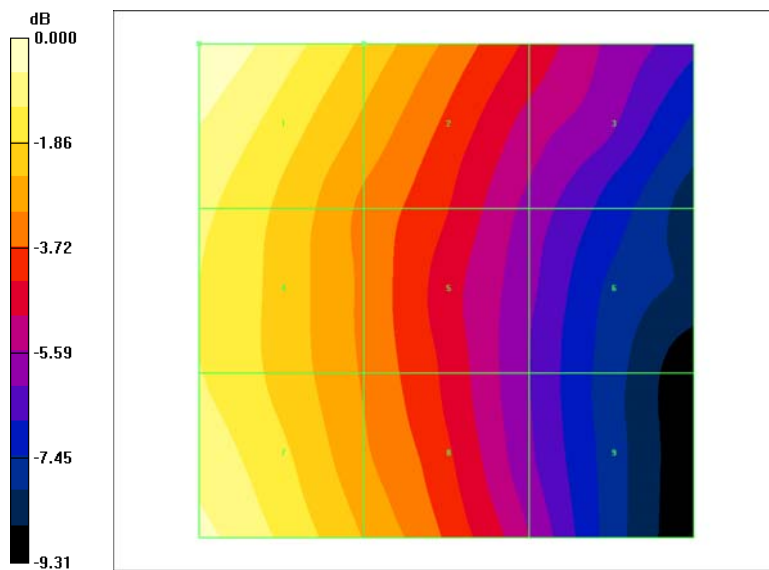
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.047 A/m; Power Drift = 0.189 dB

**Hearing Aid Near-Field Category: M4 (AWF -5 dB)**

Peak H-field in A/m

Grid 1 <b>0.235 M4</b>	Grid 2 <b>0.187 M4</b>	Grid 3 <b>0.141 M4</b>
Grid 4 <b>0.208 M4</b>	Grid 5 <b>0.163 M4</b>	Grid 6 <b>0.121 M4</b>
Grid 7 <b>0.224 M4</b>	Grid 8 <b>0.176 M4</b>	Grid 9 <b>0.124 M4</b>



0 dB = 0.235A/m

**Plot #8**

**850 H Field Testing High CH**

**DUT: VeryCool USA Inc.; Type: Mobile phone; Serial: R1109169-1**

Communication System: GSM 850; Frequency: 848.8 MHz; Duty Cycle: 1:8.3  
 Medium parameters used:  $\sigma = 0.97$  mho/m,  $\epsilon_r = 55.74$ ;  $\rho = 1$  kg/m<sup>3</sup>  
 Phantom section: RF Section

DASY4 Configuration:

- Probe: H3DV6 - SN6158; ; Calibrated: 9/22/2009
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn456; Calibrated: 12/7/2010
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial:
- Measurement SW: DASY4, V4.7 Build 80; Post processing SW: SEMCAD, V1.8 Build 186

**H Scan 10mm above CD 835 MHz/Hearing Aid Compatibility Test (61x61x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.249 A/m

Probe Modulation Factor = 2.88

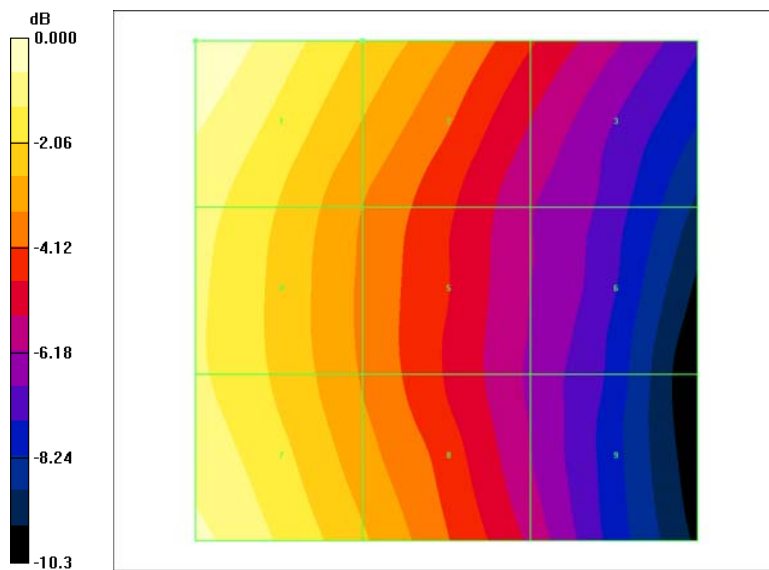
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.050 A/m; Power Drift = -0.011 dB

**Hearing Aid Near-Field Category: M4 (AWF -5 dB)**

Peak H-field in A/m

Grid 1 <b>0.249 M4</b>	Grid 2 <b>0.194 M4</b>	Grid 3 <b>0.145 M4</b>
Grid 4 <b>0.219 M4</b>	Grid 5 <b>0.167 M4</b>	Grid 6 <b>0.123 M4</b>
Grid 7 <b>0.235 M4</b>	Grid 8 <b>0.183 M4</b>	Grid 9 <b>0.130 M4</b>



0 dB = 0.248A/m

**Plot #9**

**1900 H Field Testing Low CH**

**DUT: VeryCool USA Inc.; Type: Mobile phone; Serial: R1109169-1**

Communication System: PCS 1900; Frequency: 1850.2 MHz; Duty Cycle: 1:8.3  
 Medium parameters used:  $\sigma = 0$  mho/m,  $\epsilon_r = 1$ ;  $\rho = 1$  kg/m<sup>3</sup>  
 Phantom section: RF Section

DASY4 Configuration:

- Probe: H3DV6 - SN6158; ; Calibrated: 9/22/2009
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn456; Calibrated: 12/7/2010
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial:
- Measurement SW: DASY4, V4.7 Build 80; Post processing SW: SEMCAD, V1.8 Build 186

**H Scan 10mm above CD 835 MHz/Hearing Aid Compatibility Test (61x61x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.166 A/m

Probe Modulation Factor = 2.88

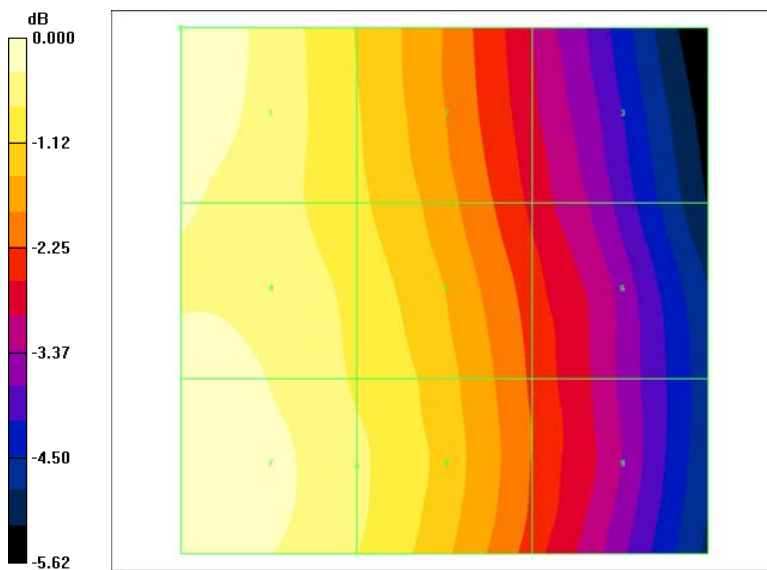
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.048 A/m; Power Drift = -0.081 dB

**Hearing Aid Near-Field Category: M3 (AWF -5 dB)**

Peak H-field in A/m

Grid 1 <b>0.166 M3</b>	Grid 2 <b>0.148 M3</b>	Grid 3 <b>0.121 M4</b>
Grid 4 <b>0.161 M3</b>	Grid 5 <b>0.151 M3</b>	Grid 6 <b>0.127 M4</b>
Grid 7 <b>0.163 M3</b>	Grid 8 <b>0.154 M3</b>	Grid 9 <b>0.128 M4</b>



0 dB = 0.166A/m

**Plot #10**

**1900 H Field Testing Mid CH**

**DUT: VeryCool USA Inc.; Type: Mobile phone; Serial: R1109169-1**

Communication System: PCS 1900; Frequency: 1880 MHz; Duty Cycle: 1:8.3  
 Medium parameters used:  $\sigma = 0$  mho/m,  $\epsilon_r = 1$ ;  $\rho = 1$  kg/m<sup>3</sup>  
 Phantom section: RF Section

DASY4 Configuration:

- Probe: H3DV6 - SN6158; ; Calibrated: 9/22/2009
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn456; Calibrated: 12/7/2010
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial:
- Measurement SW: DASY4, V4.7 Build 80; Post processing SW: SEMCAD, V1.8 Build 186

**H Scan 10mm above CD 835 MHz/Hearing Aid Compatibility Test (61x61x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.160 A/m

Probe Modulation Factor = 2.88

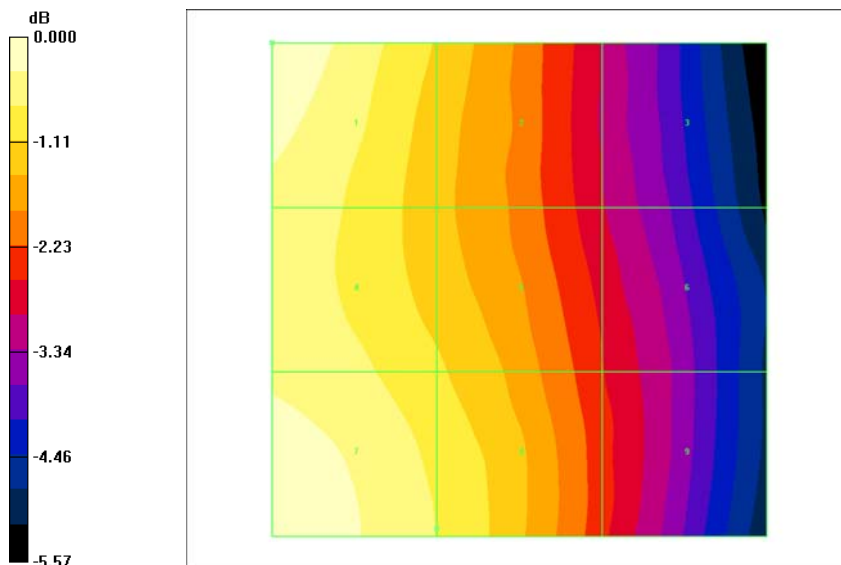
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.044 A/m; Power Drift = 0.065 dB

**Hearing Aid Near-Field Category: M3 (AWF -5 dB)**

Peak H-field in A/m

Grid 1 <b>0.160 M3</b>	Grid 2 <b>0.140 M3</b>	Grid 3 <b>0.114 M4</b>
Grid 4 <b>0.153 M3</b>	Grid 5 <b>0.142 M3</b>	Grid 6 <b>0.119 M4</b>
Grid 7 <b>0.157 M3</b>	Grid 8 <b>0.147 M3</b>	Grid 9 <b>0.121 M4</b>



0 dB = 0.160A/m

**Plot #11**



**1900 H Field Testing High CH**

**DUT: VeryCool USA Inc.; Type: Mobile phone; Serial: R1109169-1**

Communication System: PCS 1900; Frequency: 1909.8 MHz; Duty Cycle: 1:8.3  
 Medium parameters used:  $\sigma = 0$  mho/m,  $\epsilon_r = 1$ ;  $\rho = 1$  kg/m<sup>3</sup>  
 Phantom section: RF Section

DASY4 Configuration:

- Probe: H3DV6 - SN6158; ; Calibrated: 9/22/2009
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn456; Calibrated: 12/7/2010
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial:
- Measurement SW: DASY4, V4.7 Build 80; Post processing SW: SEMCAD, V1.8 Build 186

**H Scan 10mm above CD 835 MHz/Hearing Aid Compatibility Test (61x61x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.154 A/m

Probe Modulation Factor = 2.88

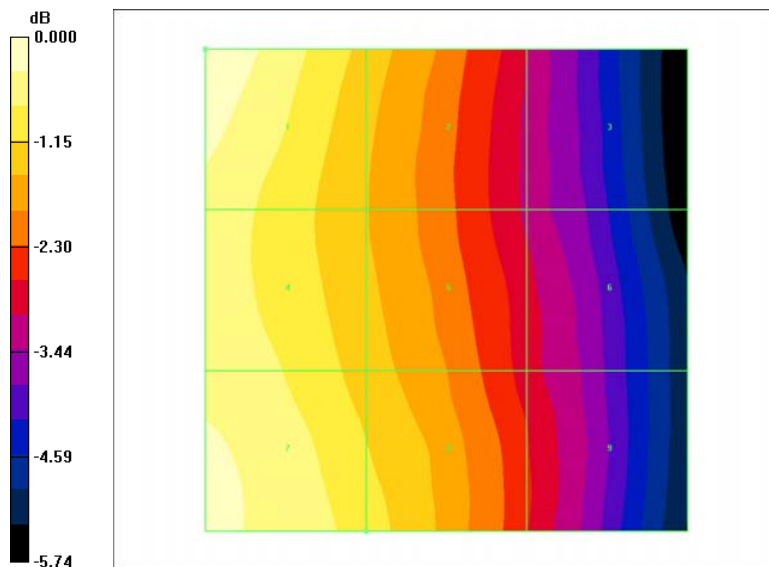
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.042 A/m; Power Drift = 0.028 dB

**Hearing Aid Near-Field Category: M3 (AWF -5 dB)**

Peak H-field in A/m

Grid 1 <b>0.154 M3</b>	Grid 2 <b>0.133 M4</b>	Grid 3 <b>0.108 M4</b>
Grid 4 <b>0.145 M3</b>	Grid 5 <b>0.132 M4</b>	Grid 6 <b>0.111 M4</b>
Grid 7 <b>0.149 M3</b>	Grid 8 <b>0.138 M4</b>	Grid 9 <b>0.114 M4</b>



0 dB = 0.154A/m

**Plot #12**

# 10 APPENDIX B – PROBE CALIBRATION CERTIFICATIONS

**Calibration Laboratory of  
Schmid & Partner  
Engineering AG**  
Zeughausstrasse 43, 8004 Zurich, Switzerland



**S** Schweizerischer Kalibrierdienst  
**C** Service suisse d'étalonnage  
**S** Servizio svizzero di taratura  
**S** Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)  
The Swiss Accreditation Service is one of the signatories to the EA  
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client **BACL**

Certificate No: **ER3-2338\_Sep08**

## CALIBRATION CERTIFICATE

Object: **ER3DV6 - SN:2338**

Calibration procedure(s): **QA CAL-02.v5  
Calibration procedure for E-field probes optimized for close near field  
evaluations in air**

Calibration date: **September 22, 2009**

Condition of the calibrated item: **In Tolerance**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).  
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter E4419B	GB41293874	1-Apr-08 (No. 217-00768)	Apr-09
Power sensor E4412A	MY41495277	1-Apr-08 (No. 217-00788)	Apr-09
Power sensor E4412A	MY41498067	1-Apr-08 (No. 217-00788)	Apr-09
Reference 3 dB Attenuator	SN: 35054 (3c)	1-Jul-08 (No. 217-00805)	Jul-09
Reference 20 dB Attenuator	SN: S5086 (20b)	31-Mar-08 (No. 217-00787)	Apr-09
Reference 30 dB Attenuator	SN: S5129 (30b)	1-Jul-08 (No. 217-00866)	Jul-09
Reference Probe ER3DV6	SN: 2328	2-Oct-07 (No. ER3-2328_Oct07)	Oct-08
DAE4	SN: 769	5-Dec-07 (No. DAE4-769_Dec07)	Dec-08

Secondary Standards	ID #	Check Date (in house)	Scheduled Check
RF generator HP 8648C	US3642U01700	4-Aug-99 (in house check Oct-07)	In house check: Oct-09
Network Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-07)	In house check: Oct-09

	Name	Function	Signature
Calibrated by:	Katja Pokovic	Technical Manager	
Approved by:	Niels Kuster	Quality Manager	

Issued: September 22, 2009

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

**Calibration Laboratory of  
Schmid & Partner  
Engineering AG**  
Zeughausstrasse 43, 8004 Zurich, Switzerland



**S** Schweizerischer Kalibrierdienst  
**C** Service suisse d'étalonnage  
**S** Servizio svizzero di taratura  
**S** Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)  
The Swiss Accreditation Service is one of the signatories to the EA  
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

**Glossary:**

**NORM<sub>x,y,z</sub>** sensitivity in free space  
**DCP** diode compression point  
**Polarization  $\phi$**   $\phi$  rotation around probe axis  
**Polarization  $\vartheta$**   $\vartheta$  rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e.,  $\vartheta = 0$  is normal to probe axis  
**Connector Angle** information used in DASY system to align probe sensor X to the robot coordinate system

**Calibration is Performed According to the Following Standards:**

- a) IEEE Std 1309-2005, "IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005.

**Methods Applied and Interpretation of Parameters:**

- **NORM<sub>x,y,z</sub>**: Assessed for E-field polarization  $\vartheta = 0$  for XY sensors and  $\vartheta = 90$  for Z sensor ( $f \leq 900$  MHz in TEM-cell;  $f > 1800$  MHz: R22 waveguide).
- **NORM(f)<sub>x,y,z</sub>** = **NORM<sub>x,y,z</sub>** \* *frequency\_response* (see Frequency Response Chart).
- **DCP<sub>x,y,z</sub>**: DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency.
- **Spherical isotropy (3D deviation from isotropy)**: in a locally homogeneous field realized using an open waveguide setup.
- **Sensor Offset**: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- **Connector Angle**: The angle is assessed using the information gained by determining the **NORM<sub>x</sub>** (no uncertainty required).

**ER3DV6 SN:2338**

**September 22, 2009**

# Probe ER3DV6

## SN:2338

Manufactured:	June 15, 2004
Last calibrated:	September 25, 2006
Recalibrated:	September 22, 2009

**Calibrated for DASY Systems**

(Note: non-compatible with DASY2 system!)

Certificate No: ER3-2338\_Sep08

Page 3 of 9

**ER3DV6 SN:2338**

**September 22, 2009**

**DASY - Parameters of Probe: ER3DV6 SN:2338**

**Sensitivity in Free Space [ $\mu\text{V}/(\text{V}/\text{m})^2$ ]**

NormX	1.64 ± 10.1 % (k=2)
NormY	1.70 ± 10.1 % (k=2)
NormZ	1.97 ± 10.1 % (k=2)

**Diode Compression<sup>A</sup>**

DCP X	95 mV
DCP Y	95 mV
DCP Z	97 mV

**Frequency Correction**

X	0.0
Y	0.0
Z	0.0

**Sensor Offset (Probe Tip to Sensor Center)**

X	2.5 mm
Y	2.5 mm
Z	2.5 mm

**Connector Angle 21 °**

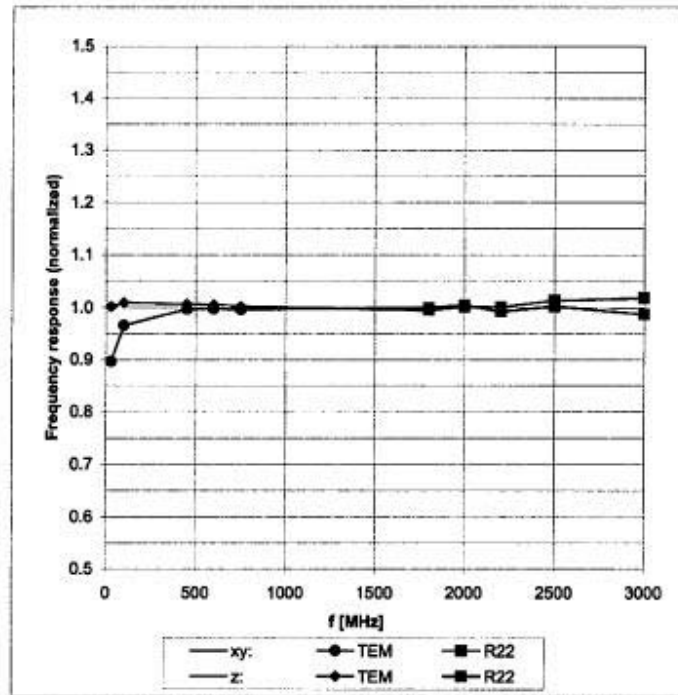
**The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.**

<sup>A</sup> numerical linearization parameter: uncertainty not required

ER3DV6 SN:2338

September 22, 2009

### Frequency Response of E-Field (TEM-Cell:ifi110 EXX, Waveguide R22)

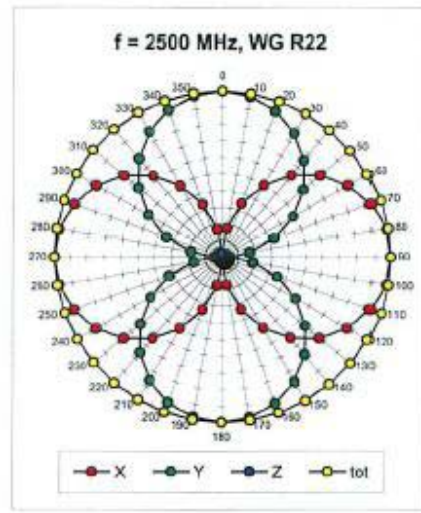
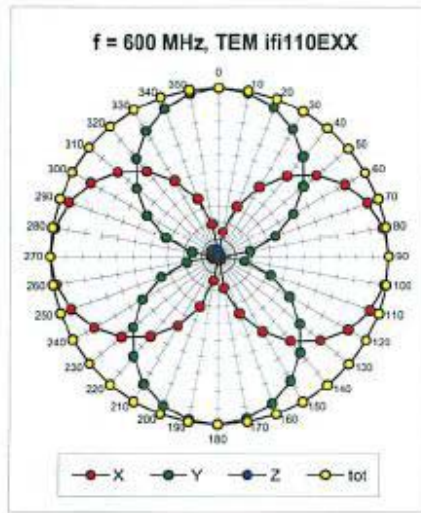


Uncertainty of Frequency Response of E-field:  $\pm 6.3\%$  (k=2)

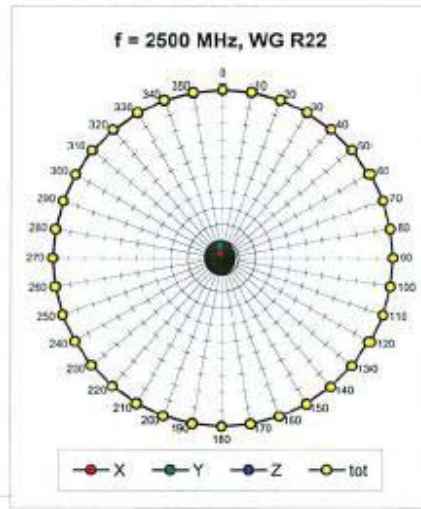
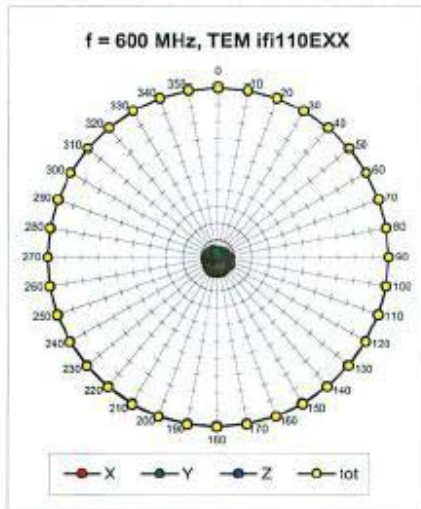
ER3DV6 SN:2338

September 22, 2009

### Receiving Pattern ( $\phi$ ), $\vartheta = 0^\circ$



### Receiving Pattern ( $\phi$ ), $\vartheta = 90^\circ$

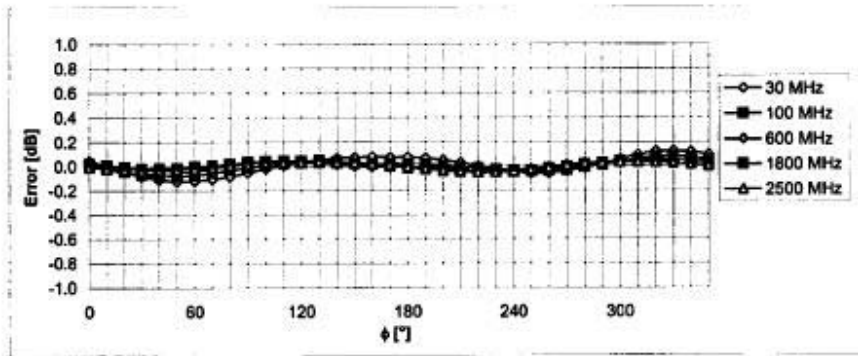




ER3DV6 SN:2338

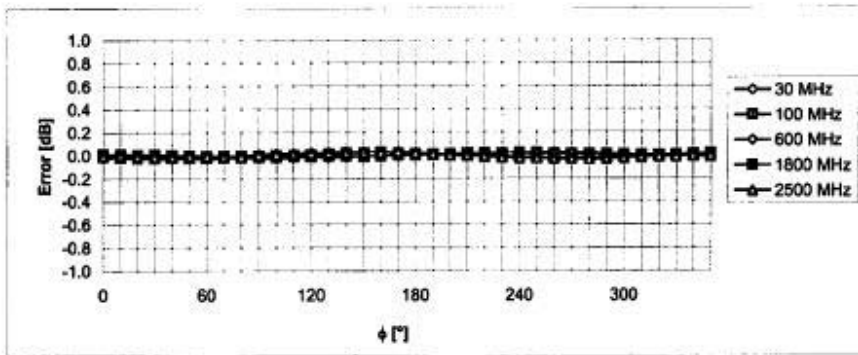
September 22, 2009

### Receiving Pattern ( $\phi$ ), $\vartheta = 0^\circ$



Uncertainty of Axial Isotropy Assessment:  $\pm 0.5\%$  (k=2)

### Receiving Pattern ( $\phi$ ), $\vartheta = 90^\circ$



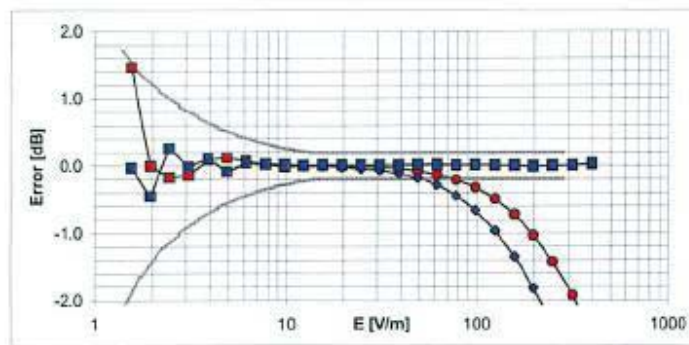
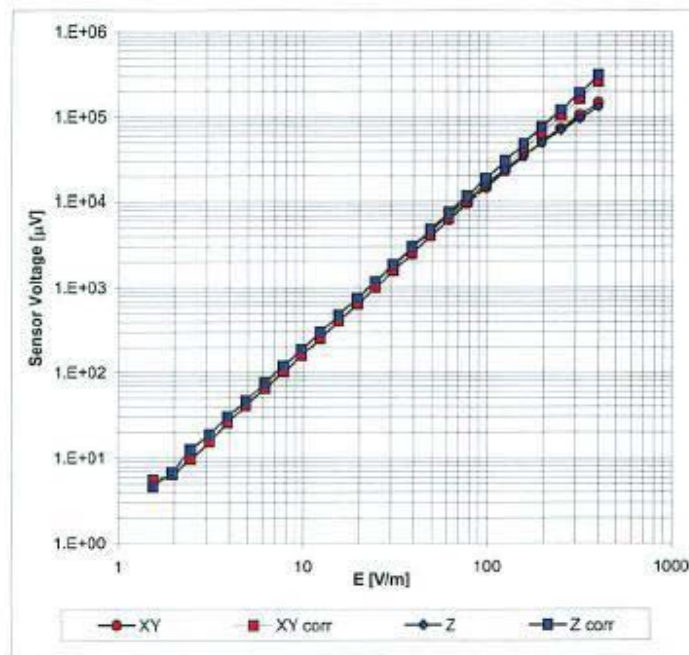
Uncertainty of Axial Isotropy Assessment:  $\pm 0.5\%$  (k=2)



ER3DV6 SN:2338

September 22, 2009

### Dynamic Range f(E-field) (Waveguide R22, f = 1800 MHz)



Uncertainty of Linearity Assessment:  $\pm 0.6\%$  (k=2)

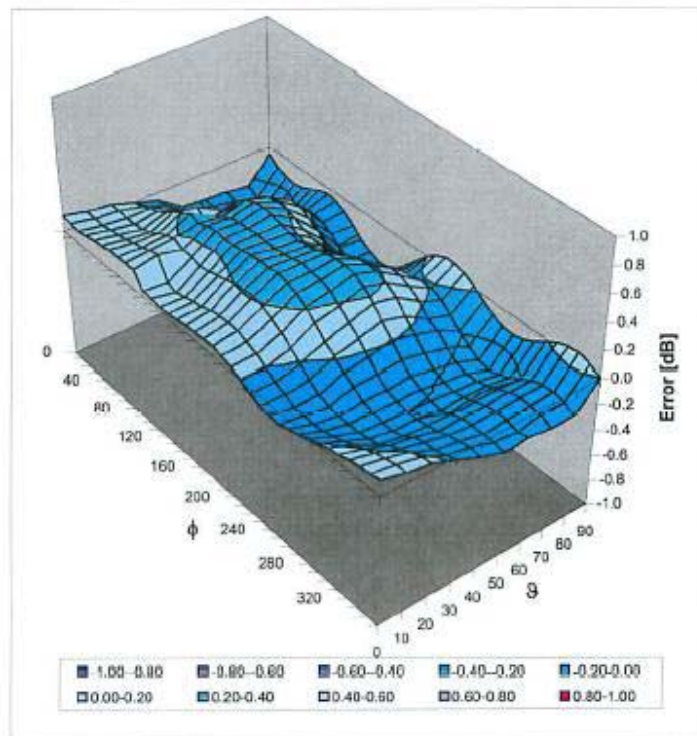
Certificate No: ER3-2338\_Sep08

Page 8 of 9

ER3DV6 SN:2338

September 22, 2009

### Deviation from Isotropy in Air Error ( $\phi, \theta$ ), $f = 900$ MHz



Uncertainty of Spherical Isotropy Assessment:  $\pm 2.6\%$  ( $k=2$ )

Certificate No: ER3-2338\_Sep08

Page 9 of 9

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Accreditation No.: **SCS 108**

Client **BACL**

Certificate No: **H3-6158\_Sep08**

**CALIBRATION CERTIFICATE**

Object: **H3DV6 - SN:6158**

Calibration procedure(s): **QA CAL-03.v5  
Calibration procedure for H-field probes optimized for close near field  
evaluations in air**

Calibration date: **September 22, 2009**

Condition of the calibrated item: **In Tolerance**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).  
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter E4419B	GB41253874	1-Apr-08 (No. 217-00788)	Apr-09
Power sensor E4412A	MY41495277	1-Apr-08 (No. 217-00788)	Apr-09
Power sensor E4412A	MY41498087	1-Apr-08 (No. 217-00788)	Apr-09
Reference 3 dB Attenuator	SN: S5054 (30)	1-Jul-08 (No. 217-00895)	Jul-09
Reference 20 dB Attenuator	SN: S5086 (20b)	31-Mar-08 (No. 217-00787)	Apr-09
Reference 30 dB Attenuator	SN: S5129 (30b)	1-Jul-08 (No. 217-00866)	Jul-09
Reference Probe H3DV6	SN: 6182	2-Oct-07 (No. H3-6182_Oct07)	Oct-08
DAE4	SN: 789	5-Dec-07 (No. DAE4-789_Dec07)	Dec-08

Secondary Standards	ID #	Check Date (in house)	Scheduled Check
RF generator HP 8648C	US3642U01700	4-Aug-99 (in house check Oct-07)	In house check: Oct-09
Network Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-07)	In house check: Oct-08

Calibrated by:	Name <b>Katja Pokovic</b>	Function <b>Technical Manager</b>	Signature 
Approved by:	Name <b>Niels Kuster</b>	Function <b>Quality Manager</b>	Signature 

Issued: September 22, 2009

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**Glossary:**

**NORM<sub>x,y,z</sub>** sensitivity in free space  
**DCP** diode compression point  
**Polarization  $\phi$**   $\phi$  rotation around probe axis  
**Polarization  $\vartheta$**   $\vartheta$  rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e.,  $\vartheta = 0$  is normal to probe axis  
**Connector Angle** information used in DASY system to align probe sensor X to the robot coordinate system

**Calibration is Performed According to the Following Standards:**

- a) IEEE Std 1309-2005, "IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005.

**Methods Applied and Interpretation of Parameters:**

- **$X, Y, Z_{a0a1a2}$** : Assessed for E-field polarization  $\vartheta = 90$  for XY sensors and  $\vartheta = 0$  for Z sensor ( $f \leq 900$  MHz in TEM-cell;  $f > 1800$  MHz: R22 waveguide).
- **$X, Y, Z(f)_{a0a1a2} = X, Y, Z_{a0a1a2} \cdot \text{frequency\_response}$**  (see Frequency Response Chart).
- **$DCP_{x,y,z}$** : DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency.
- **Spherical isotropy (3D deviation from isotropy)**: in a locally homogeneous field realized using an open waveguide setup.
- **Sensor Offset**: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- **Connector Angle**: The angle is assessed using the information gained by determining the  $X_{a0a1a2}$  (no uncertainty required).

**H3DV6 SN:6158**

**September 22, 2009**

# Probe H3DV6

## SN:6158

Manufactured:	June 22, 2004
Last calibrated:	September 25, 2006
Recalibrated:	September 22, 2009

**Calibrated for DASY Systems**

(Note: non-compatible with DASY2 system!)

H3DV6 SN:6158

September 22, 2009

**DASY - Parameters of Probe: H3DV6 SN:6158**

Sensitivity in Free Space [A/m /  $\sqrt{\mu\text{V}}$ ]

	a0	a1	a2
X	2.617E-03	-5.925E-5	3.143E-5 ± 5.1 % (k=2)
Y	2.590E-03	-8.373E-5	1.400E-6 ± 5.1 % (k=2)
Z	2.996E-03	-1.719E-4	4.549E-5 ± 5.1 % (k=2)

Diode Compression<sup>1</sup>

DCP X	85 mV
DCP Y	91 mV
DCP Z	83 mV

Sensor Offset (Probe Tip to Sensor Center)

X	3.0 mm
Y	3.0 mm
Z	3.0 mm

Connector Angle 100 °

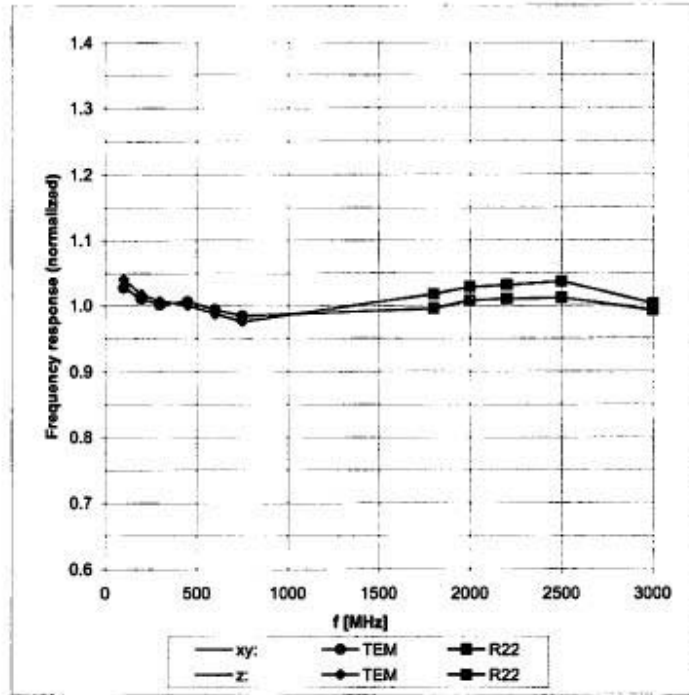
The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

<sup>1</sup> numerical linearization parameter; uncertainty not required

H3DV6 SN:6158

September 22, 2009

### Frequency Response of H-Field (TEM-Cell:ifi110 EXX, Waveguide R22)



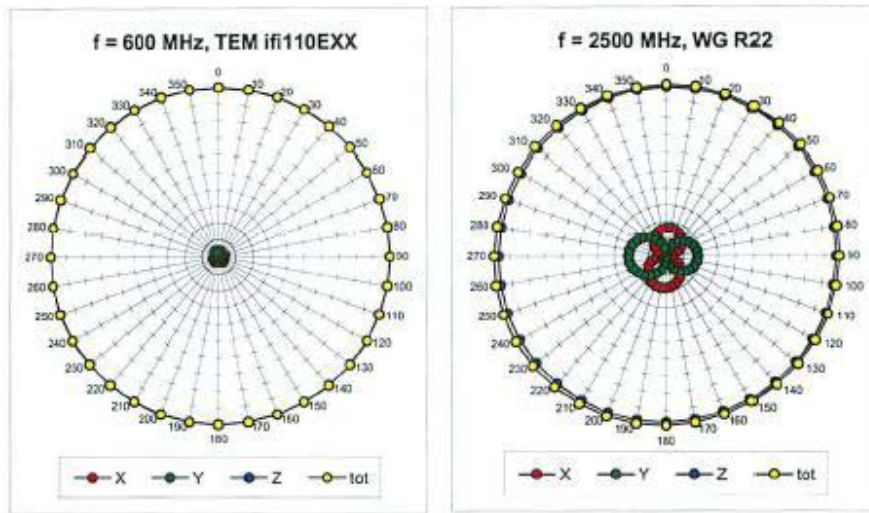
Uncertainty of Frequency Response of E-field:  $\pm 6.3\%$  (k=2)



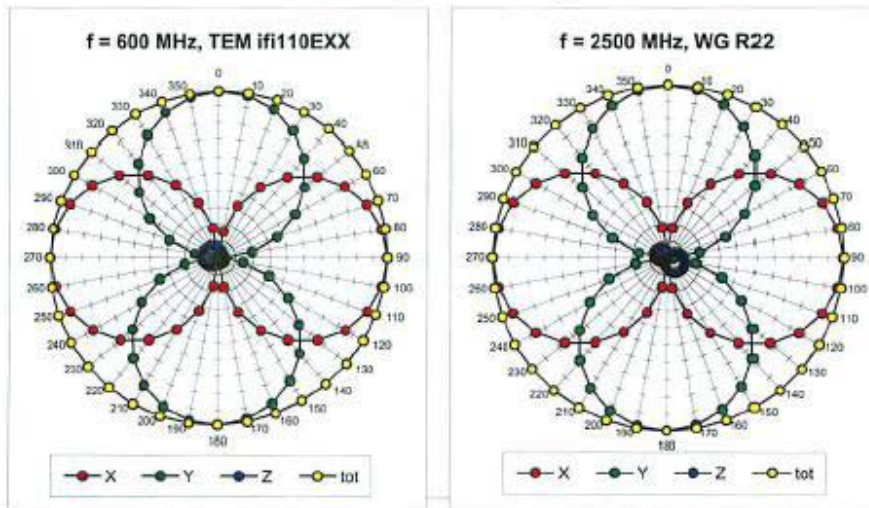
H3DV6 SN:6158

September 22, 2009

### Receiving Pattern ( $\phi$ ), $\vartheta = 90^\circ$



### Receiving Pattern ( $\phi$ ), $\vartheta = 0^\circ$

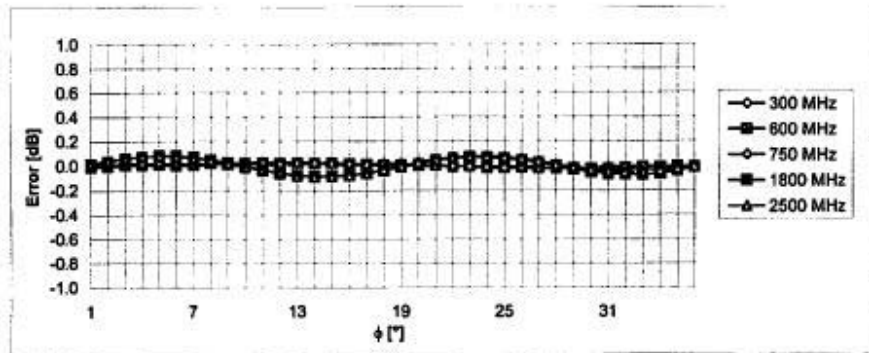




H3DV6 SN:6158

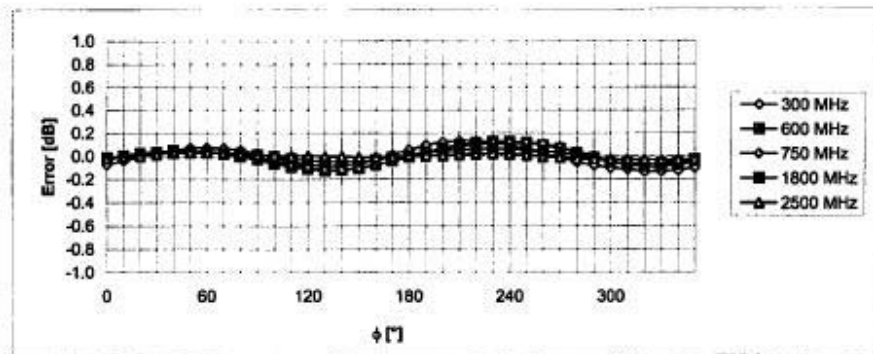
September 22, 2009

### Receiving Pattern ( $\phi$ ), $\theta = 90^\circ$



Uncertainty of Axial Isotropy Assessment:  $\pm 0.5\%$  (k=2)

### Receiving Pattern ( $\phi$ ), $\theta = 0^\circ$

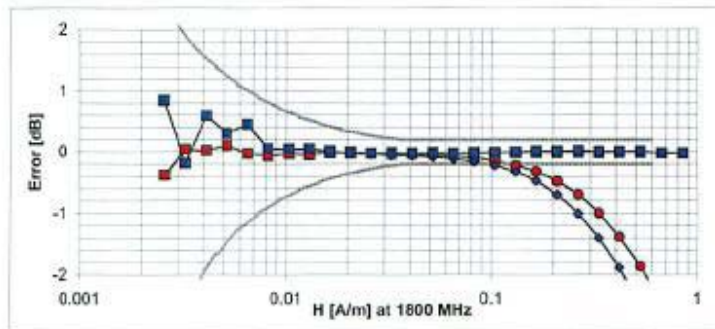
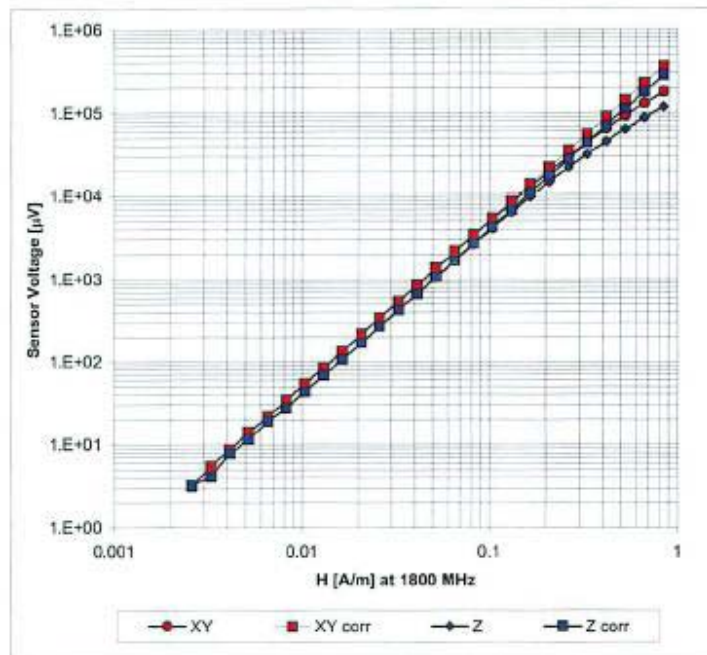


Uncertainty of Axial Isotropy Assessment:  $\pm 0.5\%$  (k=2)

H3DV6 SN:6158

September 22, 2009

### Dynamic Range f(H-field) (Waveguide R22, f = 1800 MHz)

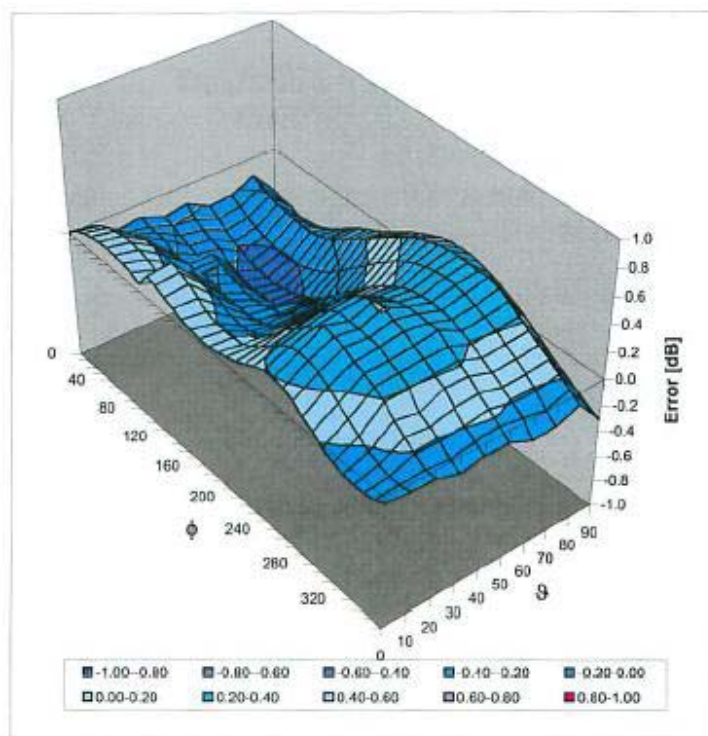


Uncertainty of Linearity Assessment:  $\pm 0.6\%$  (k=2)

H3DV6 SN:6158

September 22, 2009

### Deviation from Isotropy in Air Error ( $\phi, \vartheta$ ), $f = 900$ MHz



Uncertainty of Spherical Isotropy Assessment:  $\pm 2.6\%$  ( $k=2$ )

# 11 APPENDIX C – DIPOLE CALIBRATION CERTIFICATES

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Accreditation No.: **SCS 108**

Client **BACL**

Certificate No: **CD835V3-1012\_Sep08**

## CALIBRATION CERTIFICATE

Object **CD835V3 - SN: 1012**

Calibration procedure(s) **QA CAL-20.v4  
Calibration procedure for dipoles in air**

Calibration date: **September 17, 2009**

Condition of the calibrated item **In Tolerance**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).  
All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter EPM-442A	GB37480704	04-Oct-07 (No. 217-00736)	Oct-08
Power sensor HP 8481A	US37292783	04-Oct-07 (No. 217-00736)	Oct-08
Probe ER3DV6	SN: 2336	31-Dec-07 (No. ER3-2336_Dec07)	Dec-08
Probe H3DV6	SN: 6065	31-Dec-07 (No. H3-6065_-Dec07)	Dec-08
DAE4	SN: 781	2-Oct-07 (No. DAE4-781_Oct07)	Oct-08
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Power meter EPM-4419B	GB42420191	11-May-05 (in house check Oct-07)	In house check: Oct-08
Power sensor HP 8482A	US37295597	11-May-05 (in house check Oct-07)	In house check: Oct-08
Power sensor HP 8482H	3318A09450	08-Jan-02 (in house check Oct-07)	In house check: Oct-08
Network Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-07)	In house check: Oct-08
RF generator E4433B	MY 41310391	22-Nov-04 (in house check Oct-07)	In house check: Oct-09

Calibrated by: **Name** Claudio Leubler **Function** Laboratory Technician **Signature**

Approved by: **Name** Fin Bornholt **Function** Technical Director **Signature**

Issued: September 17, 2009

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Accreditation No.: **SCS 108**

#### References

- [1] ANSI-C63.19-2006  
American National Standard for Methods of Measurement of Compatibility between Wireless  
Communications Devices and Hearing Aids.

#### Methods Applied and Interpretation of Parameters:

- **Coordinate System:** y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with standard [1], the measurement planes (probe sensor center) are selected to be at a distance of 10 mm above the top edge of the dipole arms.
- **Measurement Conditions:** Further details are available from the hardcopies at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- **Antenna Positioning:** The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY4 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- **Feed Point Impedance and Return Loss:** These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminated by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- **E-field distribution:** E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 10 mm (in z) above the top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, 10mm above the dipole surface.
- **H-field distribution:** H-field is measured with an isotropic H-field probe with 100mW forward power to the antenna feed point, in the x-y-plane. The scan area and sensor distance is equivalent to the E-field scan. The maximum of the field is available at the center (subgrid 5) above the feed point. The H-field value stated as calibration value represents the maximum of the interpolated H-field, 10mm above the dipole surface at the feed point.

### 1 Measurement Conditions

DASY system configuration, as far as not given on page 1.

<b>DASY Version</b>	DASY4	V4.7 B71
<b>DASY PP Version</b>	SEMCAD	V1.8 B184
<b>Phantom</b>	HAC Test Arch	SD HAC P01 BA, #1070
<b>Distance Dipole Top - Probe Center</b>	10 mm	
<b>Scan resolution</b>	dx, dy = 5 mm	area = 20 x 180 mm
<b>Frequency</b>	835 MHz ± 1 MHz	
<b>Forward power at dipole connector</b>	20.0 dBm = 100mW	
<b>Input power drift</b>	< 0.05 dB	

### 2 Maximum Field values

H-field 10 mm above dipole surface	condition	interpolated maximum
Maximum measured	100 mW forward power	0.455 A/m

Uncertainty for H-field measurement: 8.2% (k=2)

E-field 10 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end-	100 mW forward power	169.7 V/m
Maximum measured above low end	100 mW forward power	161.0 V/m
Averaged maximum above arm	100 mW forward power	165.4 V/m

Uncertainty for E-field measurement: 12.8% (k=2)

### 3 Appendix

#### 3.1 Antenna Parameters

Frequency	Return Loss	Impedance
800 MHz	15.5 dB	( 42.8 - j14.1 ) Ohm
835 MHz	34.2 dB	( 50.2 + j1.9 ) Ohm
900 MHz	17.2 dB	( 54.9 - j13.7 ) Ohm
950 MHz	18.6 dB	( 43.0 + j8.4 ) Ohm
960 MHz	14.9 dB	( 49.5 + j18.1 ) Ohm

#### 3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

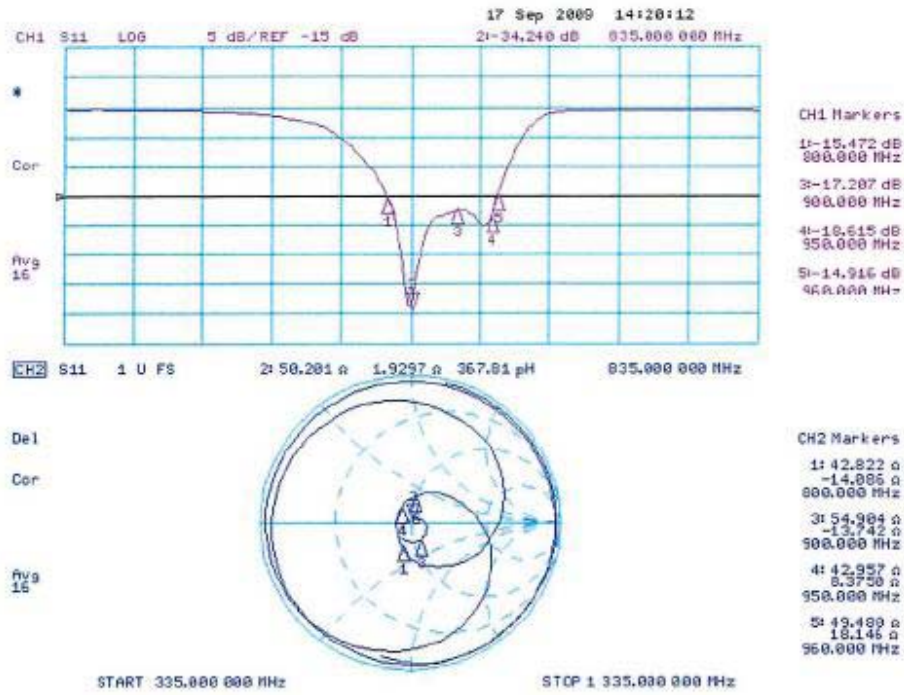
Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.



3.3 Measurement Sheets

3.3.1 Return Loss and Smith Chart



**3.3.2 DASY4 H-field result**

Date/Time: 16.09.2009 13:04:52

Test Laboratory: SPEAG Lab 2

**H\_CD835\_1012\_080916**

**DUT: HAC-Dipole 835 MHz; Type: D835V3; Serial: 1012**

Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1

Medium parameters used:  $\sigma = 0$  mho/m,  $\epsilon_r = 1$ ;  $\rho = 1$  kg/m<sup>3</sup>

Phantom section: RF Section

Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: H3DV6 - SN6065; ; Calibrated: 31.12.2007
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 02.10.2007
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

**H Scan - measurement distance from the probe sensor center to CD835 Dipole = 10mm/Hearing Aid**

**Compatibility Test (41x361x1):**

Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.455 A/m

Probe Modulation Factor = 1.00

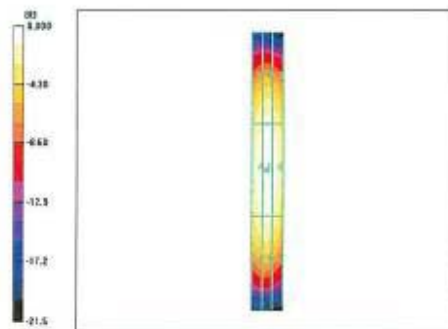
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.484 A/m; Power Drift = 0.006 dB

**Hearing Aid Near-Field Category: M4 (AWF 0 dB)**

Peak H-field in A/m

Grid 1 <b>0.389 M4</b>	Grid 2 <b>0.408 M4</b>	Grid 3 <b>0.381 M4</b>
Grid 4 <b>0.436 M4</b>	Grid 5 <b>0.455 M4</b>	Grid 6 <b>0.424 M4</b>
Grid 7 <b>0.388 M4</b>	Grid 8 <b>0.405 M4</b>	Grid 9 <b>0.371 M4</b>



0 dB = 0.455A/m



**3.3.3 DASY4 E-field result**

Date/Time: 17.09.2009 13:03:59

Test Laboratory: SPEAG Lab 2

**E\_CD835\_1012\_080917**

**DUT: HAC-Dipole 835 MHz; Type: D835V3; Serial: 1012**

Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1

Medium parameters used:  $\sigma = 0$  mho/m,  $\epsilon_r = 1$ ;  $\rho = 1000$  kg/m<sup>3</sup>

Phantom section: RF Section

Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: ER3DV6 - SN2336; ConvF(1, 1, 1); Calibrated: 31.12.2007
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 02.10.2007
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

**E Scan - measurement distance from the probe sensor center to CD835 Dipole = 10mm/Hearing Aid**

**Compatibility Test (41x361x1):**

Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 169.7 V/m

Probe Modulation Factor = 1.00

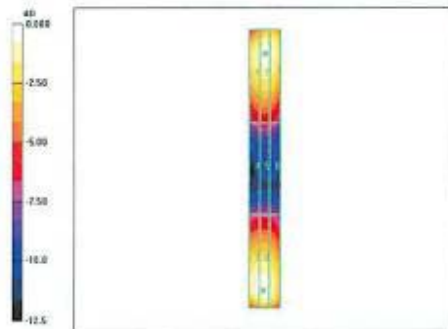
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 109.6 V/m; Power Drift = 0.011 dB

**Hearing Aid Near-Field Category: M4 (AWF 0 dB)**

Peak E-field in V/m

Grid 1 <b>155.2 M4</b>	Grid 2 <b>161.0 M4</b>	Grid 3 <b>158.2 M4</b>
Grid 4 <b>81.9 M4</b>	Grid 5 <b>83.9 M4</b>	Grid 6 <b>81.5 M4</b>
Grid 7 <b>164.6 M4</b>	Grid 8 <b>169.7 M4</b>	Grid 9 <b>159.1 M4</b>



0 dB = 169.7V/m

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Accreditation No.: **SCS 108**

Client **BACL**

Certificate No: **CD1880V3-1009\_Sep08**

**CALIBRATION CERTIFICATE**

Object **CD1880V3 - SN: 1009**

Calibration procedure(s) **QA CAL-20.v4  
Calibration procedure for dipoles in air**

Calibration date: **September 17, 2009**

Condition of the calibrated item **In Tolerance**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).  
All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter EPM-442A	GB37480704	04-Oct-07 (No. 217-00736)	Oct-08
Power sensor HP 8481A	US37292783	04-Oct-07 (No. 217-00736)	Oct-08
Probe ER3DV6	SN: 2336	31-Dec-07 (No. ER3-2336_Dec07)	Dec-08
Probe H3DV6	SN: 6065	31-Dec-07 (No. H3-6065_-Dec07)	Dec-08
DAE4	SN: 781	2-Oct-07 (No. DAE4-781_Oct07)	Oct-08

Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Power meter EPM-4419B	GB42420191	11-May-05 (in house check Oct-07)	In house check: Oct-08
Power sensor HP 8482A	US37295597	11-May-05 (in house check Oct-07)	In house check: Oct-08
Power sensor HP 8482H	3318A09450	08-Jan-02 (in house check Oct-07)	In house check: Oct-08
Network Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-07)	In house check: Oct-09

Calibrated by: **Name** Claudio Leubler **Function** Laboratory Technician **Signature** *[Signature]*

Approved by: **Name** Fin Bornholt **Function** Technical Director **Signature** *[Signature]*

Issued: September 17, 2009

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Accreditation No.: **SCS 108**

#### References

- [1] ANSI-C63.19-2006  
American National Standard for Methods of Measurement of Compatibility between Wireless  
Communications Devices and Hearing Aids.

#### Methods Applied and Interpretation of Parameters:

- **Coordinate System:** y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with standard [1], the measurement planes (probe sensor center) are selected to be at a distance of 10 mm above the top edge of the dipole arms.
- **Measurement Conditions:** Further details are available from the hardcopies at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- **Antenna Positioning:** The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY4 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- **Feed Point Impedance and Return Loss:** These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminated by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- **E-field distribution:** E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 10 mm (in z) above the top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, 10mm above the dipole surface.
- **H-field distribution:** H-field is measured with an isotropic H-field probe with 100mW forward power to the antenna feed point, in the x-y-plane. The scan area and sensor distance is equivalent to the E-field scan. The maximum of the field is available at the center (subgrid 5) above the feed point. The H-field value stated as calibration value represents the maximum of the interpolated H-field, 10mm above the dipole surface at the feed point.

**1. Measurement Conditions**

DASY system configuration, as far as not given on page 1.

DASY Version	DASY4	V4.7 B71
DASY PP Version	SEMCAD	V1.8 B184
Phantom	HAC Test Arch	SD HAC P01 BA, #1070
Distance Dipole Top - Probe Center	10 mm	
Scan resolution	dx, dy = 5 mm	area = 20 x 90 mm
Frequency	1880 MHz $\pm$ 1 MHz	
Forward power at dipole connector	20.0 dBm = 100mW	
Input power drift	< 0.05 dB	

**2. Maximum Field values**

H-field 10 mm above dipole surface	condition	Interpolated maximum
Maximum measured	100 mW forward power	0.467 A/m

Uncertainty for H-field measurement: 8.2% (k=2)

E-field 10 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW forward power	140.0 V/m
Maximum measured above low end	100 mW forward power	139.3 V/m
Averaged maximum above arm	100 mW forward power	139.7 V/m

Uncertainty for E-field measurement: 12.8% (k=2)

**3. Appendix****3.1 Antenna Parameters**

Frequency	Return Loss	Impedance
1710 MHz	25.3 dB	( 48.1 + j5.0 ) Ohm
1880 MHz	22.8 dB	( 49.8 + j7.2 ) Ohm
1900 MHz	24.4 dB	( 52.7 + j5.6 ) Ohm
1950 MHz	28.9 dB	( 53.3 - j1.6 ) Ohm
2000 MHz	22.6 dB	( 43.1 + j1.0 ) Ohm

**3.2 Antenna Design and Handling**

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

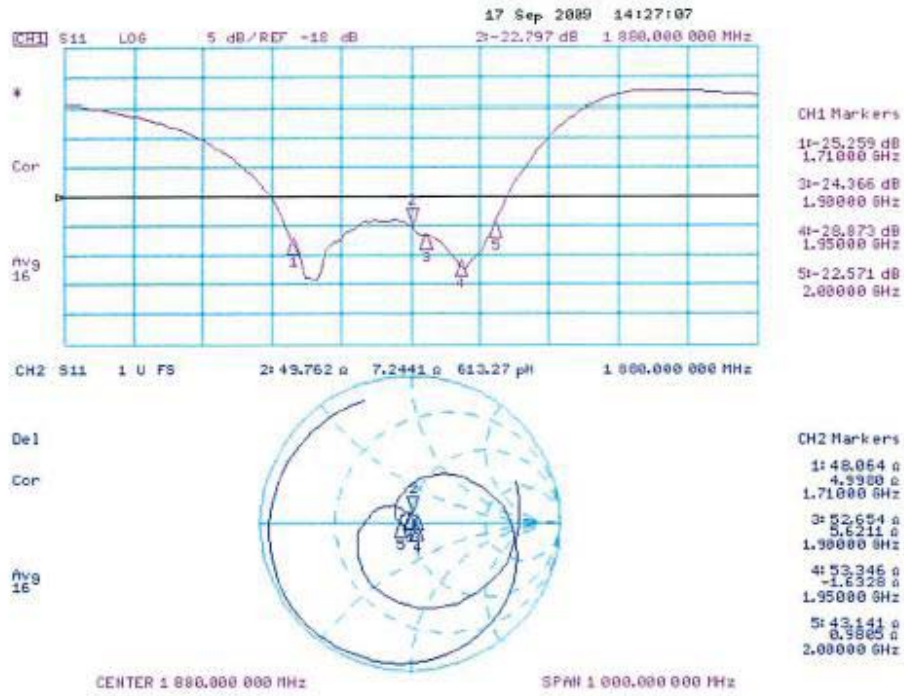
The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

3.3 Measurement Sheets

3.3.1 Return Loss and Smith Chart



**DASY4 H-Field Result**

Date/Time: 16.09.2009 14:30:31

Test Laboratory: SPEAG Lab 2

**H\_CD1880\_1009\_080916**

**DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: 1009**  
 Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1  
 Medium parameters used:  $\sigma = 0 \text{ mho/m}$ ,  $\epsilon_r = 1$ ;  $\rho = 1 \text{ kg/m}^3$   
 Phantom section: RF Section  
 Measurement Standard: DASY4 (High Precision Assessment)  
 DASY4 Configuration:

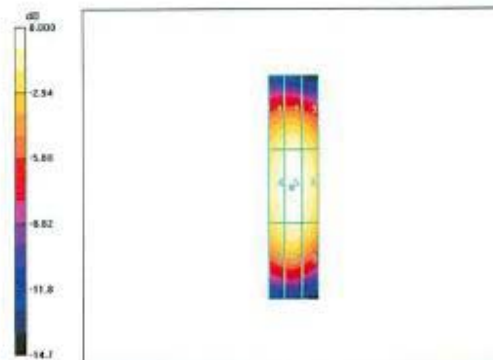
- Probe: H3DV6 - SN6065; ; Calibrated: 31.12.2007
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 02.10.2007
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

**H Scan - measurement distance from the probe sensor center to CD1880 Dipole = 10mm/Hearing Aid Compatibility Test (41x181x1):**

Measurement grid: dx=5mm, dy=5mm  
 Maximum value of peak Total field = 0.467 A/m  
 Probe Modulation Factor = 1.00  
 Device Reference Point: 0.000, 0.000, -6.30 mm  
 Reference Value = 0.495 A/m; Power Drift = -0.005 dB  
**Hearing Aid Near-Field Category: M2 (AWF 0 dB)**

Peak H-field in A/m

Grid 1 <b>0.411 M2</b>	Grid 2 <b>0.426 M2</b>	Grid 3 <b>0.401 M2</b>
Grid 4 <b>0.450 M2</b>	Grid 5 <b>0.467 M2</b>	Grid 6 <b>0.439 M2</b>
Grid 7 <b>0.412 M2</b>	Grid 8 <b>0.430 M2</b>	Grid 9 <b>0.400 M2</b>



0 dB = 0.467A/m



**3.3.2 DASY4 E-Field Result**

Date/Time: 17.09.2009 11:26:17

Test Laboratory: SPEAG Lab 2

**E\_CD1880\_1009\_080917**

**DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: 1009**

Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1

Medium parameters used:  $\sigma = 0 \text{ mho/m}$ ,  $\epsilon_r = 1$ ;  $\rho = 1000 \text{ kg/m}^3$

Phantom section: RF Section

Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: ER3DV6 - SN2336; ConvF(1, 1, 1); Calibrated: 31.12.2007
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 02.10.2007
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

**E Scan - measurement distance from the probe sensor center to CD1880 Dipole = 10mm/Hearing Aid Compatibility**

**Test (41x181x1):**

Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 140.0 V/m

Probe Modulation Factor = 1.00

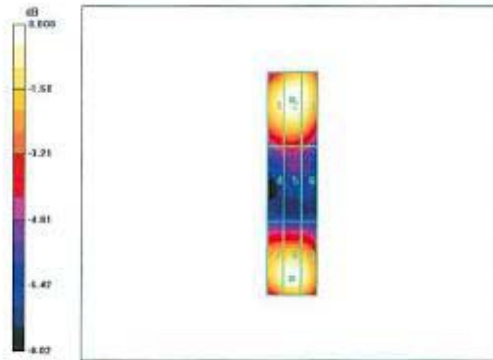
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 155.2 V/m; Power Drift = -0.007 dB

**Hearing Aid Near-Field Category: M2 (AWF 0 dB)**

Peak E-field in V/m

Grid 1 <b>135.5 M2</b>	Grid 2 <b>140.0 M2</b>	Grid 3 <b>136.7 M2</b>
Grid 4 <b>87.5 M3</b>	Grid 5 <b>89.6 M3</b>	Grid 6 <b>86.3 M3</b>
Grid 7 <b>133.9 M2</b>	Grid 8 <b>139.3 M2</b>	Grid 9 <b>134.5 M2</b>



0 dB = 140.0V/m

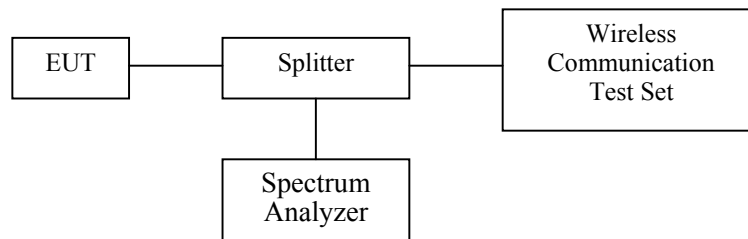
## 12 APPENDIX D – OUTPUT POWER MEASUREMENT

### 12.1 Provision Applicable

The measured peak output power should be greater and within 5 % than EMI measurement.

### 12.2 Test Procedure

The RF output of the transmitter was connected to the input of the spectrum analyzer through sufficient attenuation.



### 12.3 Test Equipment List and Details

Manufacturer	Description	Model No.	Serial No.	Calibration Date
Rohde & Schwarz	Analyzer Communication	CMU200	103492	2011-06-29

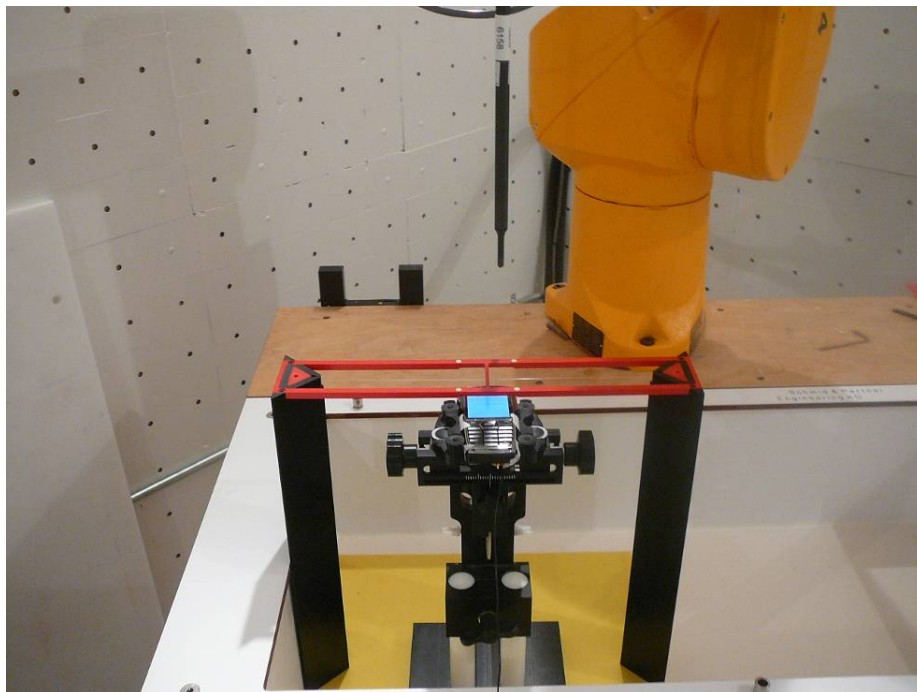
### 12.4 Summary of Test Results

Mode	Channel	Frequency (MHz)	Output Power (dBm)	Output Power (W)
GSM 850	LOW	824.2	32.91	1.95
	MIDDLE	836.6	32.97	1.98
	HIGH	848.8	32.94	1.97
PCS 1900	LOW	1850.2	29.39	0.87
	MIDDLE	1880.0	29.37	0.86
	HIGH	1909.8	29.26	0.84

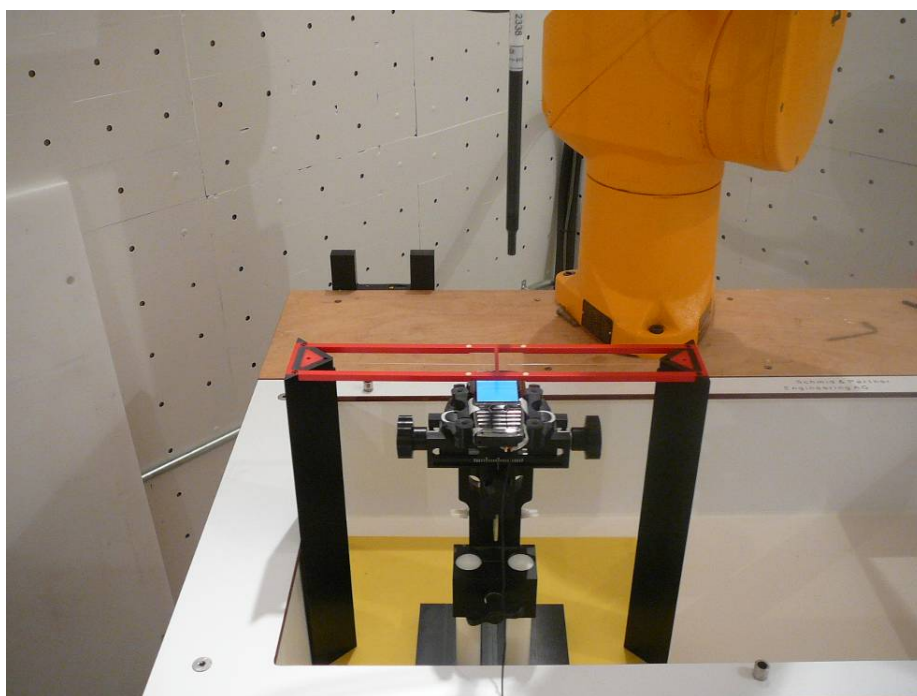


## 13 APPENDIX F – TEST SETUP PHOTOS

### 13.1 H-Field Setup View



### 13.2 E-Field Setup View



## 14 APPENDIX G– EUT PHOTOGRAPHS

### 14.1 EUT – Front View



### 14.2 EUT – Rear View



### 14.3 EUT – Battery Compartment View



### 14.4 EUT – Accessory Charger



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## **15 APPENDIX H - REFERENCES**

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[1] ANSI C63.19:2007, American National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids

[2] CFR47, Part20.19, Federal Communications Commission (FCC), Hearing Aid-Compatible Mobile Handsets

[3] FCC 08-68 A1, A2, A3, A4, A5, WT Docket 07-250, February 28, 2008.

[4] FCC OET KDB 285076, Equipment Authorization Guidance for Hearing Aid Compatibility, September 25, 2008.

**--- END OF REPORT ---**